

Proposing

An Interpolated Pipeline ADC

Akira Matsuzawa

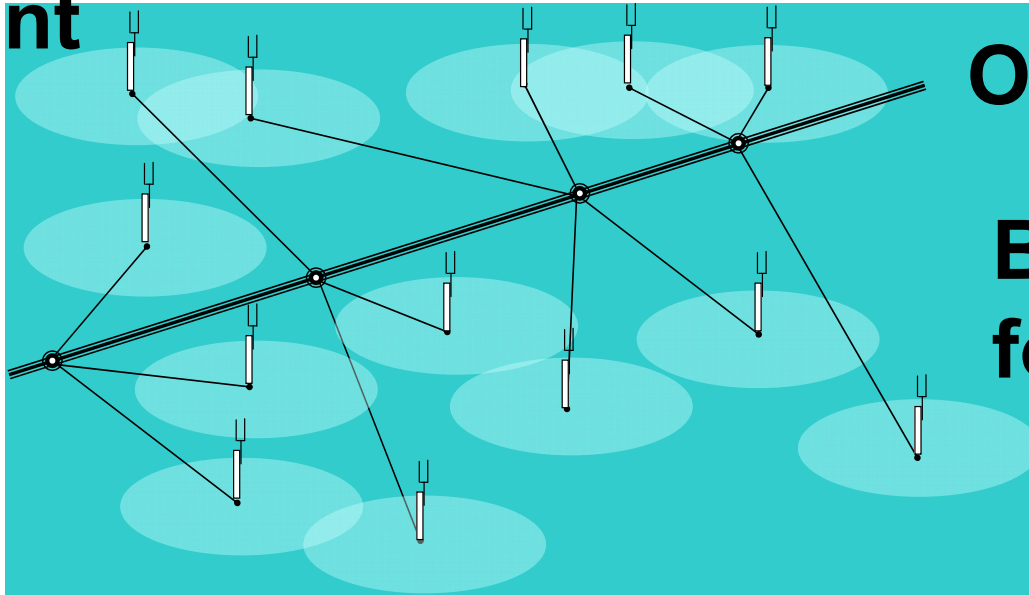
Tokyo Institute of Technology, Japan

Background

38GHz long range mm-wave system

Role of long range mm-wave

Current

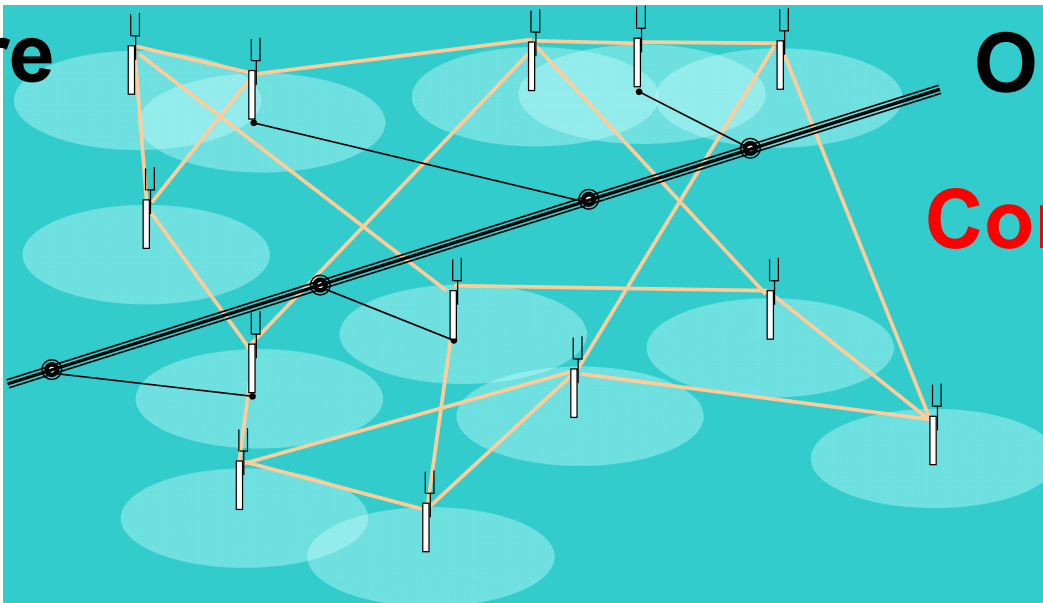


Optical fiber

**Base stations
for WiFi and WiMAX**

Not flexible

Future



Optical fiber

Connect with mm-wave

Very flexible

38GHz long range mm-wave system

realized 1Gbps long range mm-wave systems

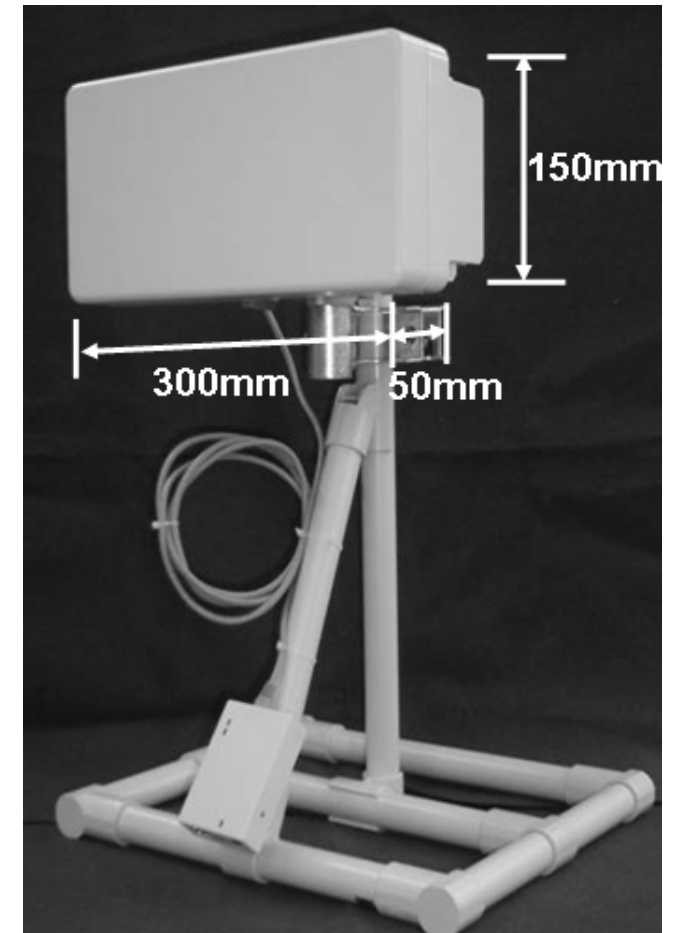
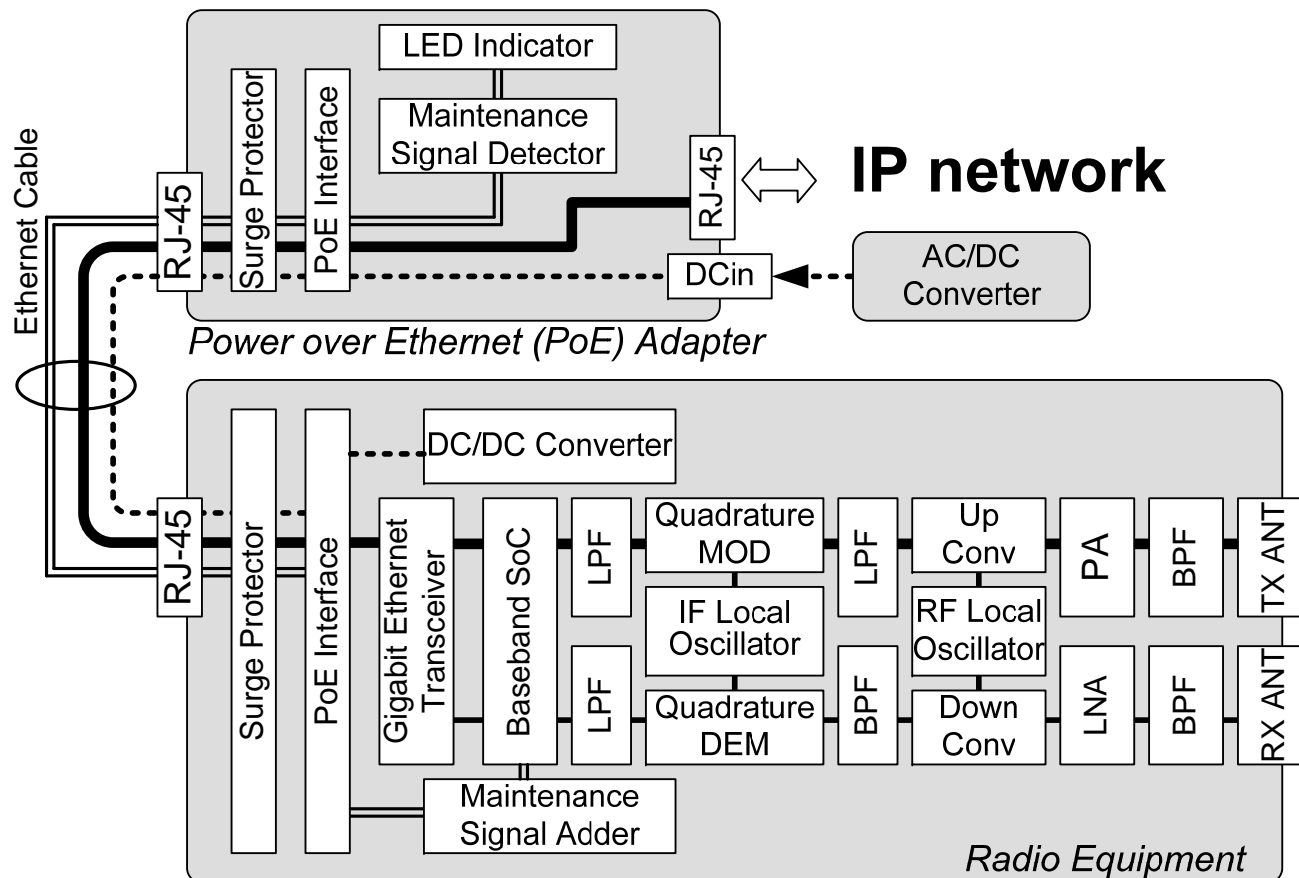


Current system: 80Mbps!!



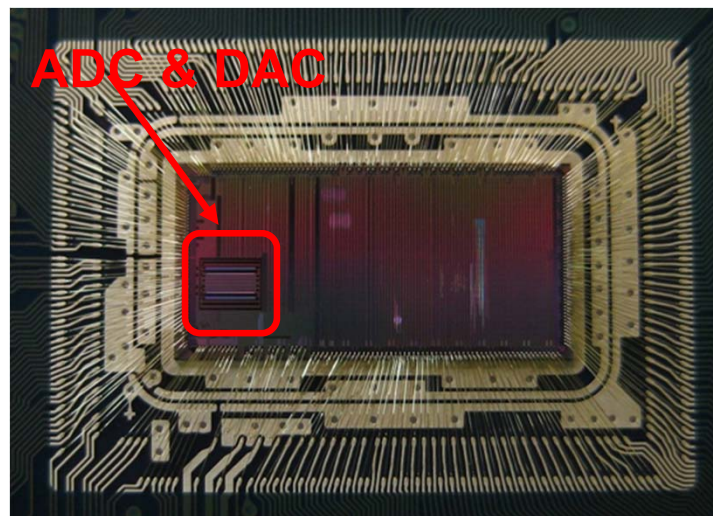
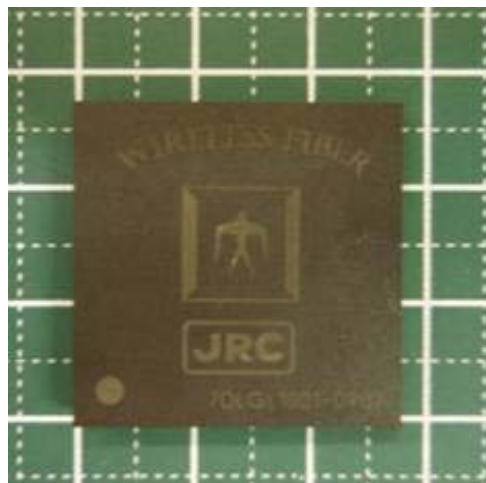
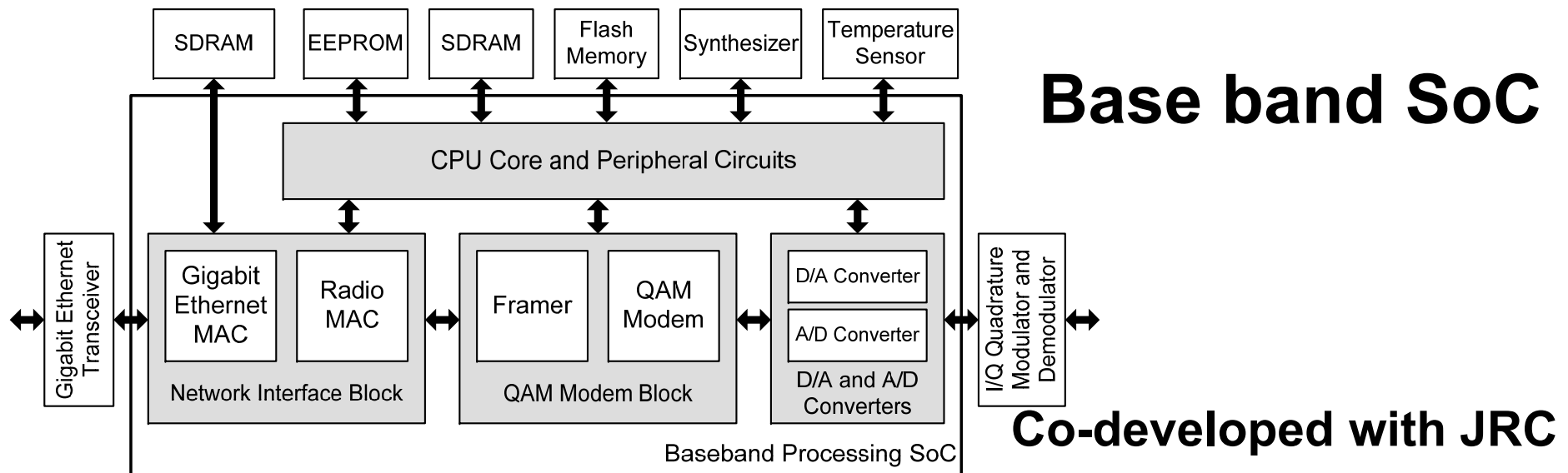
System configuration

Compatible with Gbit Ethernet
Hole system is integrated with planar antenna



Mixed signal BB SoC

A mixed signal SoC has been developed to realize 64QAM (1Gbps) with BW of 260MHz.



90nm CMOS
40M Transistors

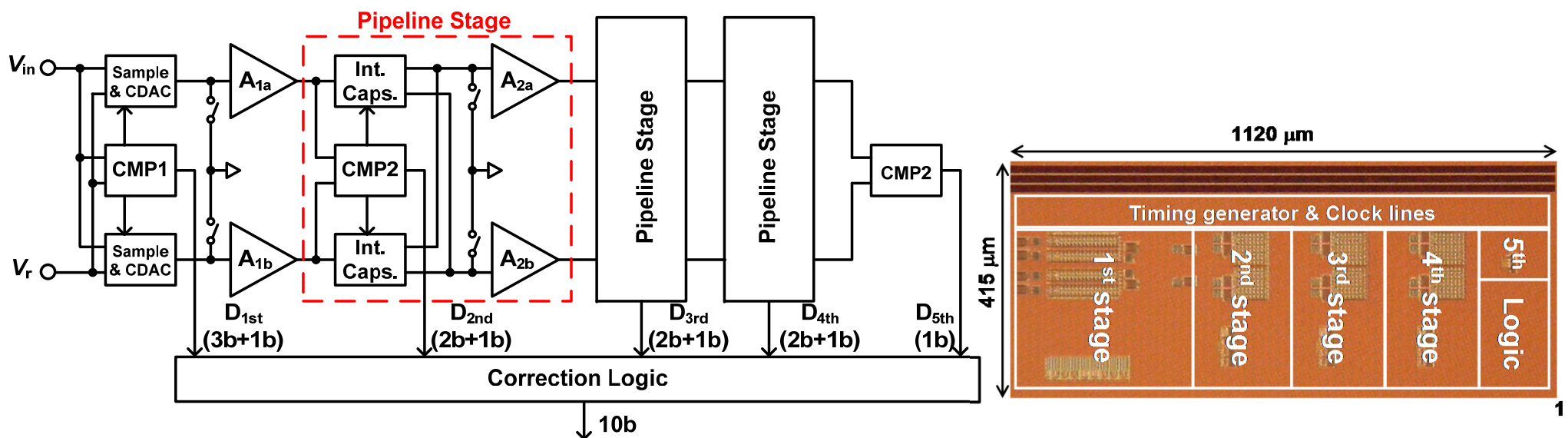
Developed ADC

Developed new 10b ADC to address 64 QAM.

Interpolated pipeline scheme
No need of high gain OP amps

10b, 320 MSps, 40mW ADC

Suitable for low gain and low V_{DD} scaled CMOS

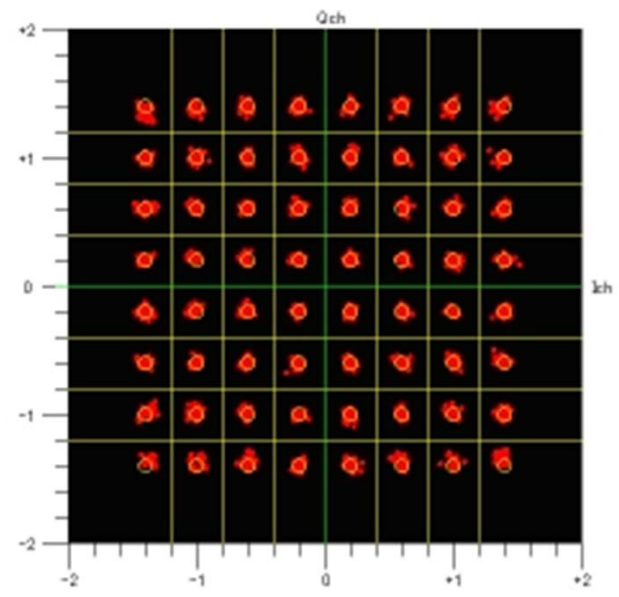
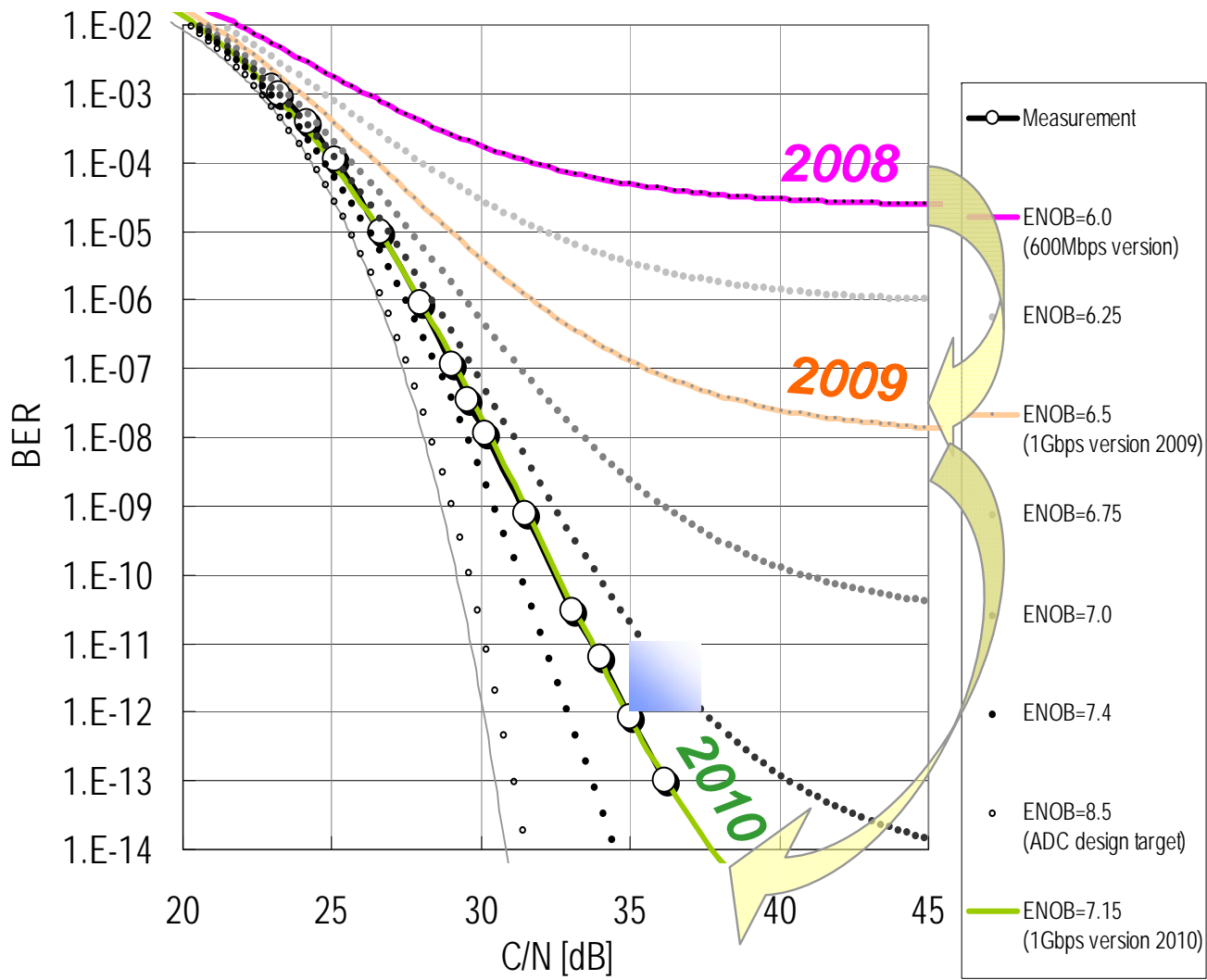


BER vs. SNR

BER for 64QAM has been reduced to the ideal

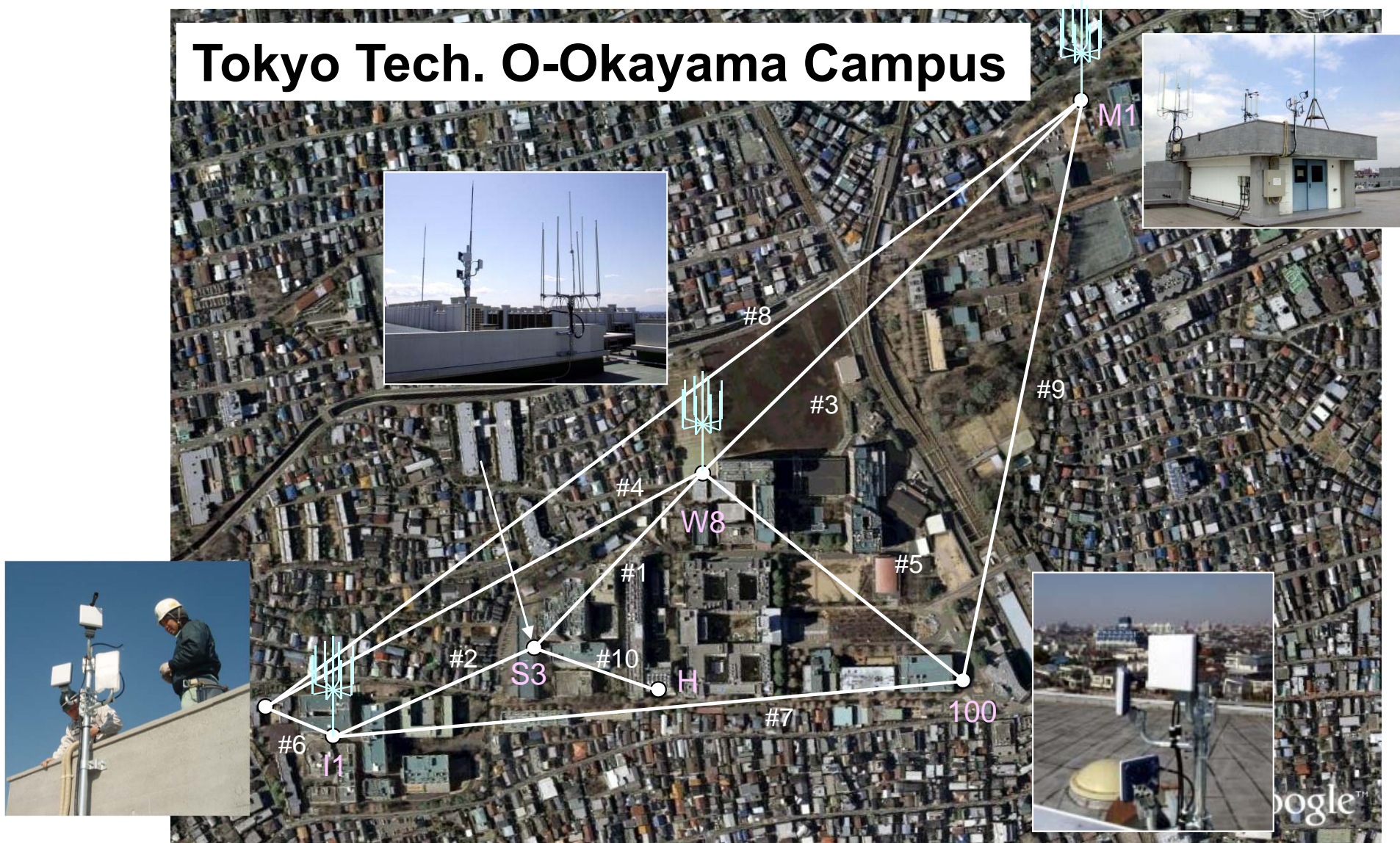
C/N vs 64QAM_BER on B-B pair

ENOB of ADC is increased



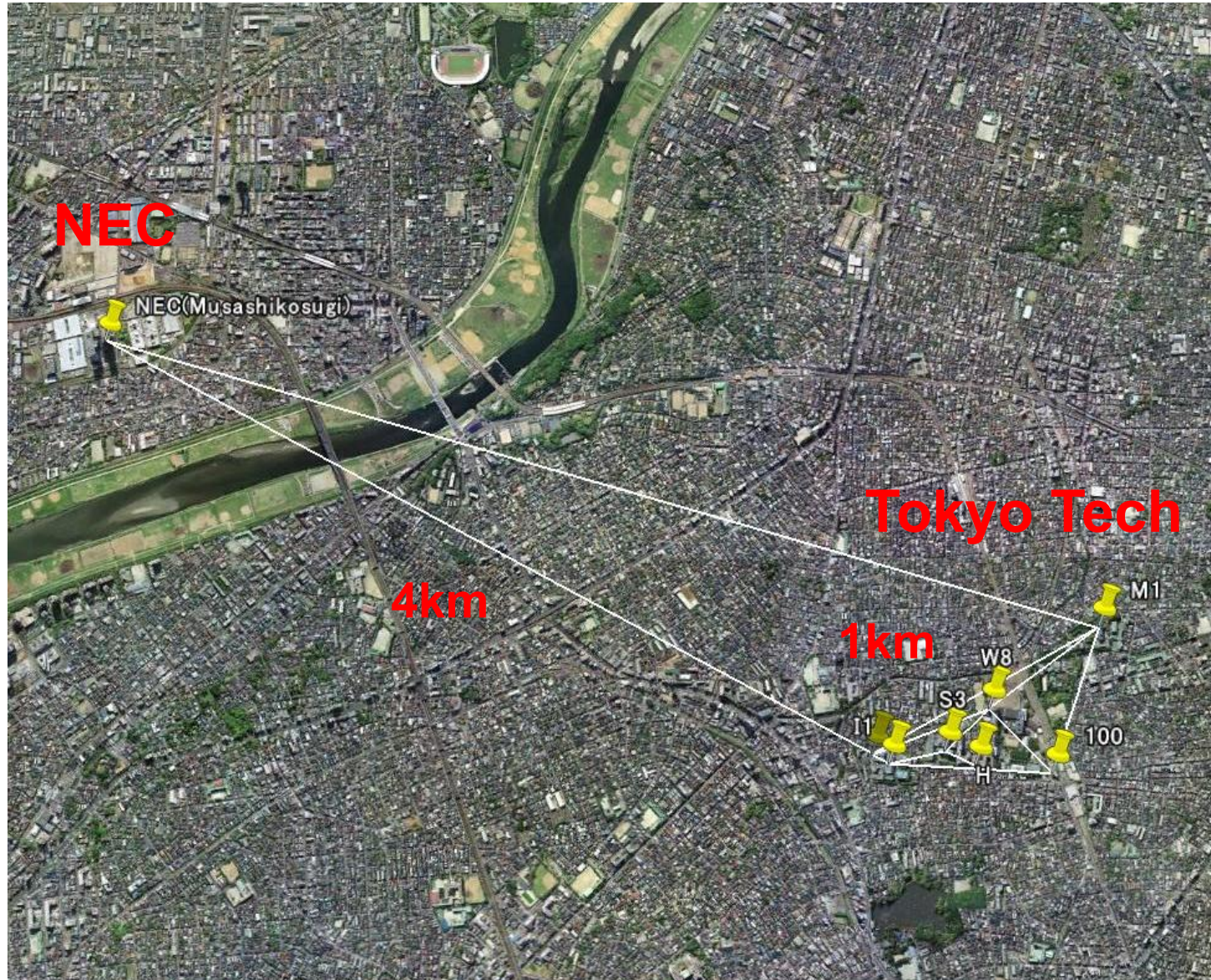
Tokyo Tech. Model Network

Ten mm-wave base stations in our campus



Expand the area to NEC (4km)

Challenge for 4km mm-wave communication

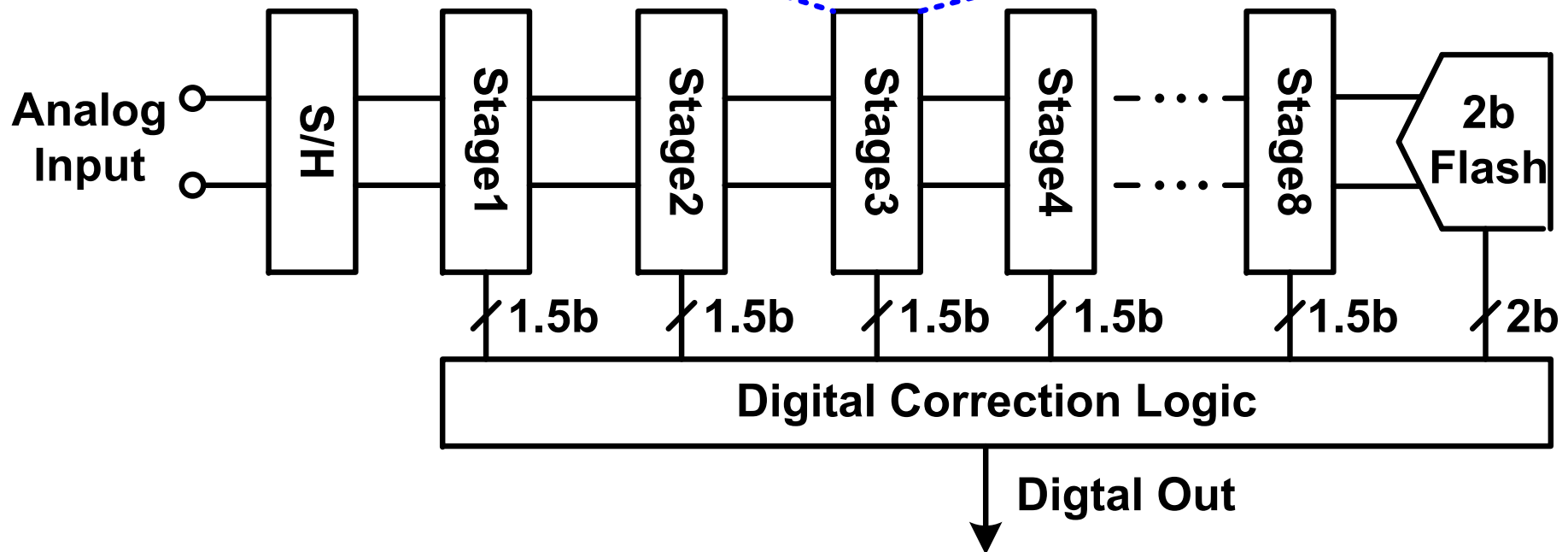
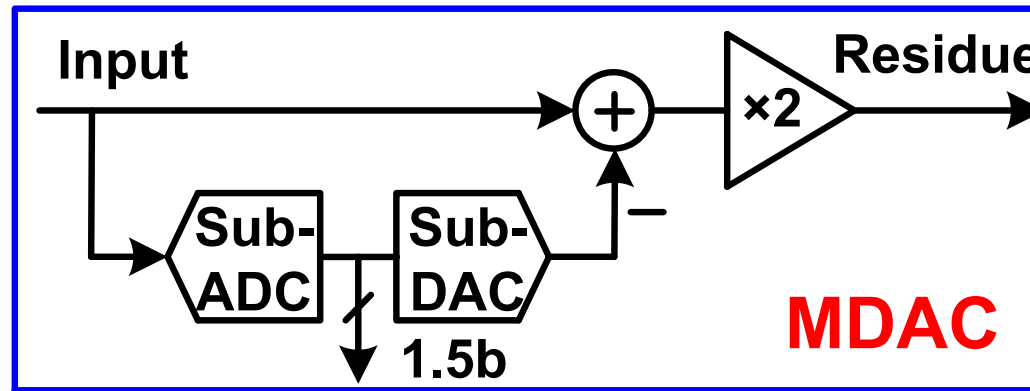


Outline

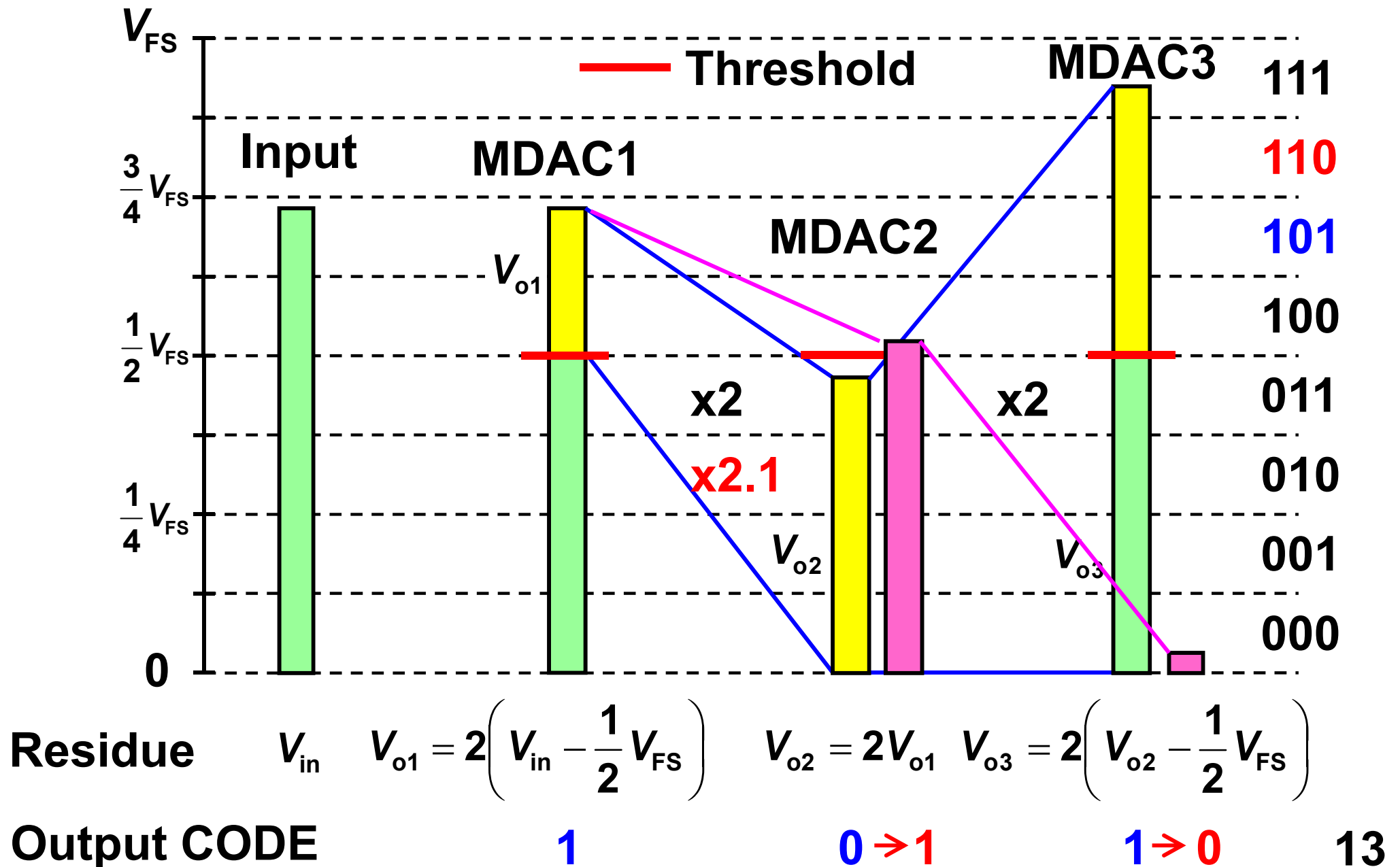
- **Introduction**
- **Interpolation Techniques**
- **Circuit Implementation**
- **Measurement Results**
- **Conclusions**

Conventional Pipelined ADC

Conventional pipelined ADC requires accurate MDAC

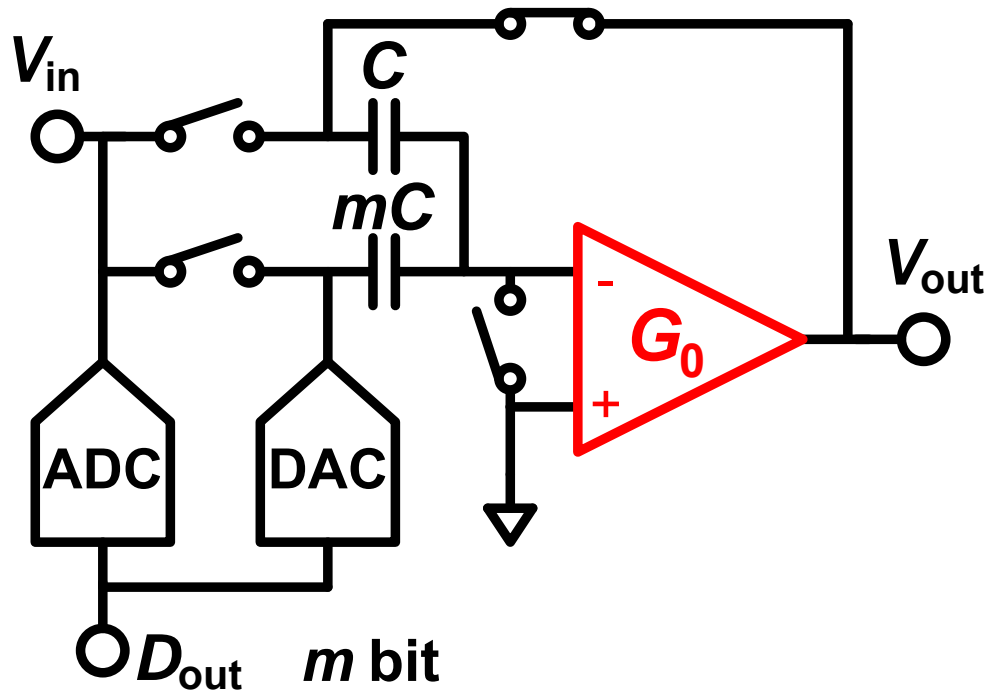


Pipelined ADC Conversion

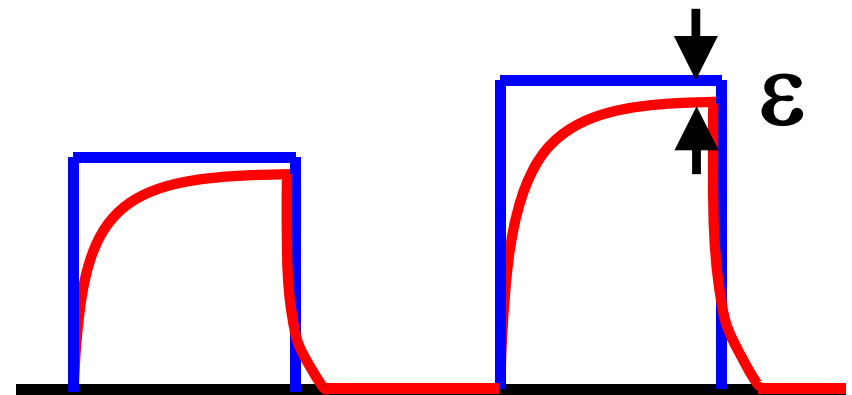


Conventional MDAC

- High DC gain OpAmp
 - Difficult to realize in scaled technology
- Closed-loop MDAC leads to lower speed



MDAC Implementation



$$G_0 (\text{dB}) > 6N + 10$$

$$GBW > NF_s$$

N : Number of bits

F_s : Sampling freq.

OpAmp gain and conversion error

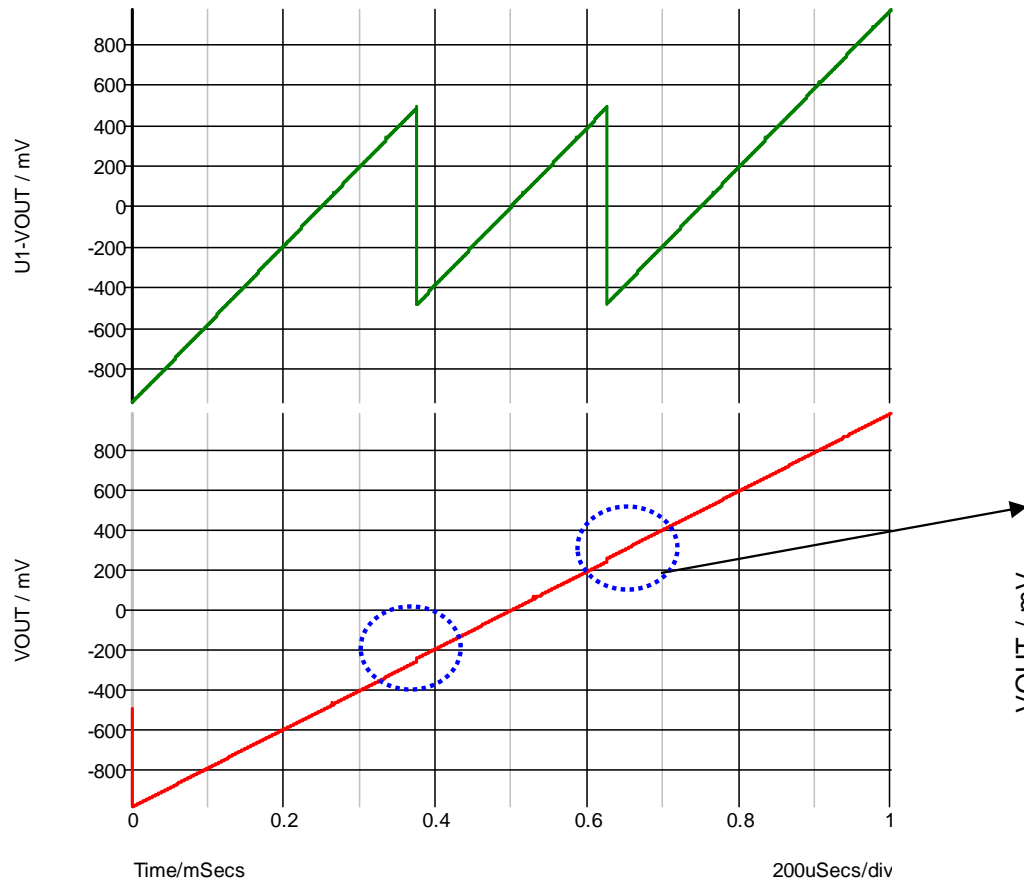
$$\epsilon_{(LSB)} = \frac{3 \times 2^N}{G} \quad G > \frac{3 \times 2^N}{\epsilon_{(LSB)}}$$

$$G > 6N + 10 \text{ (dB)}$$

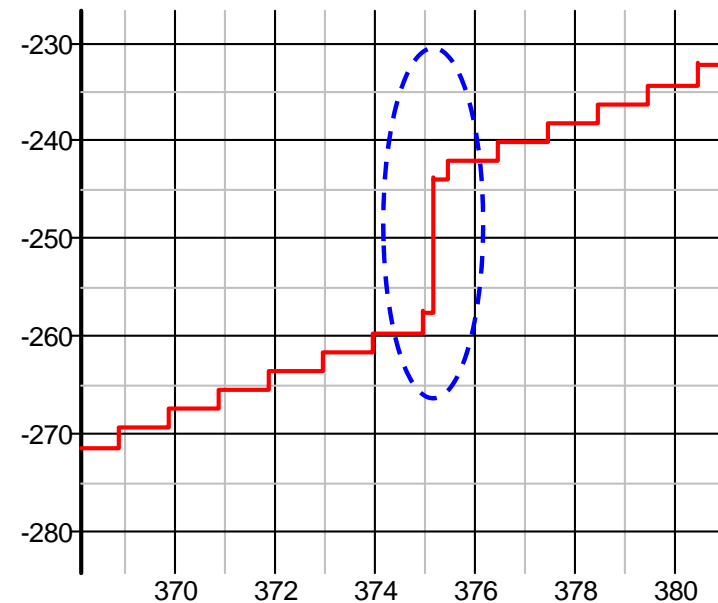
Gain > 70dB

10bit ADC

Large error occurs



40dB gain



Recent Works

- **Digital compensation technique [1, 2]**
 - **Capacitor mismatch, gain error and opamp nonlinearity can be corrected**
 - Simple analog circuit design
 - **Foreground compensation**
 - PVT variation degrade the performance
 - **Long compensation time**
 - Increase of test cost

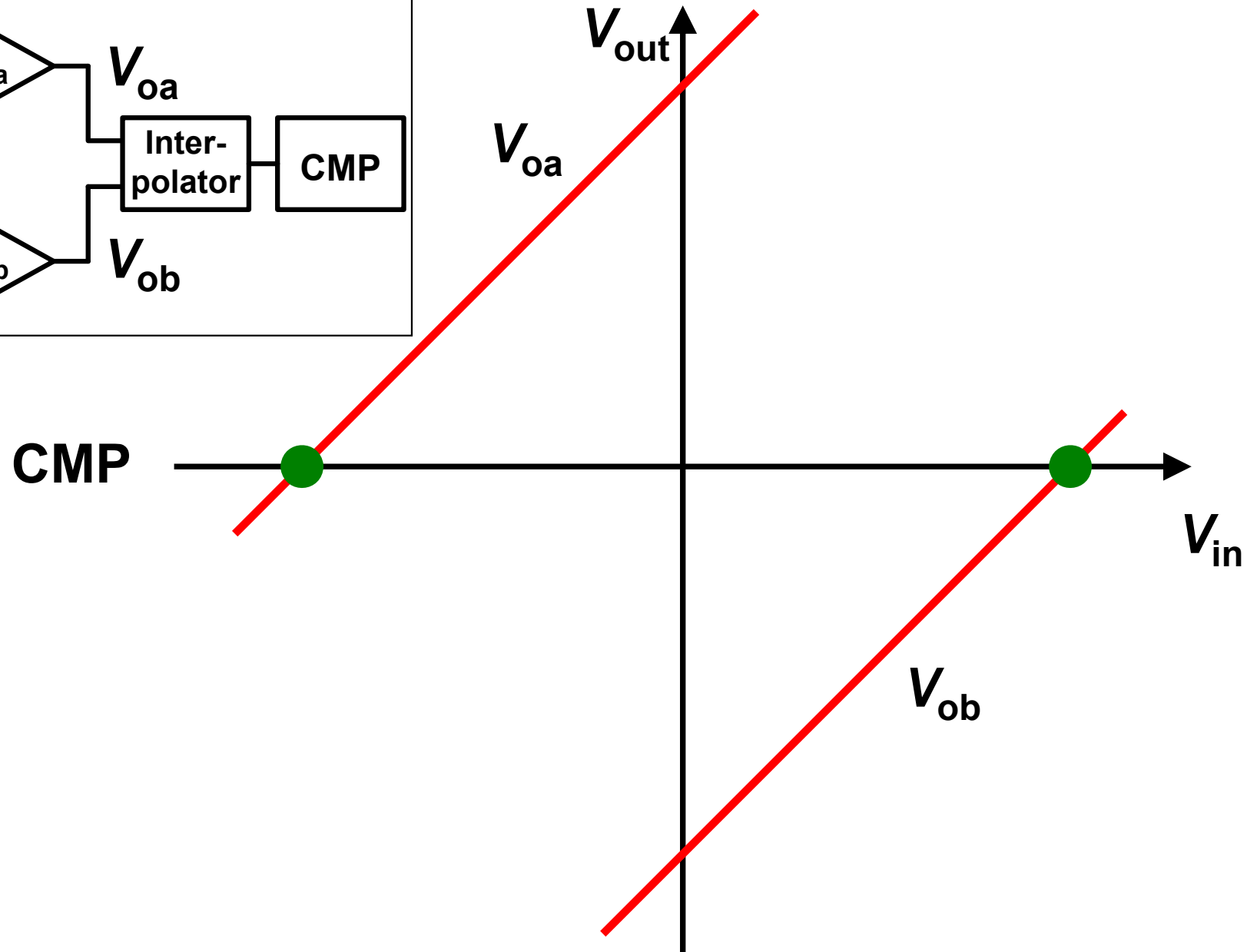
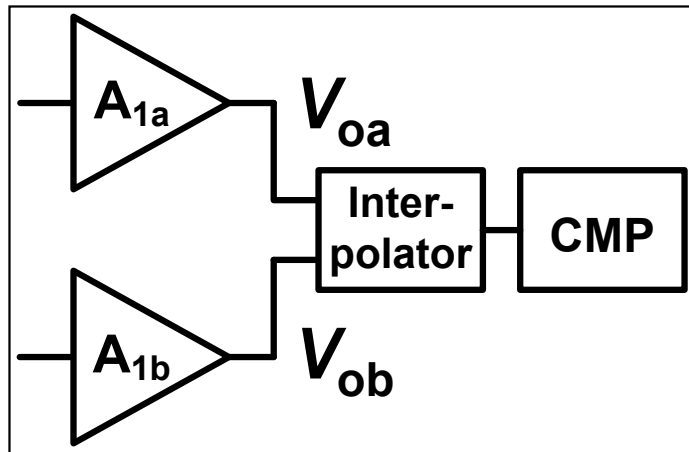
[1] B. Murmann and B. E. Boser, Dec., 2003.

[2] A. Verma and B. Razavi, Nov., 2009.

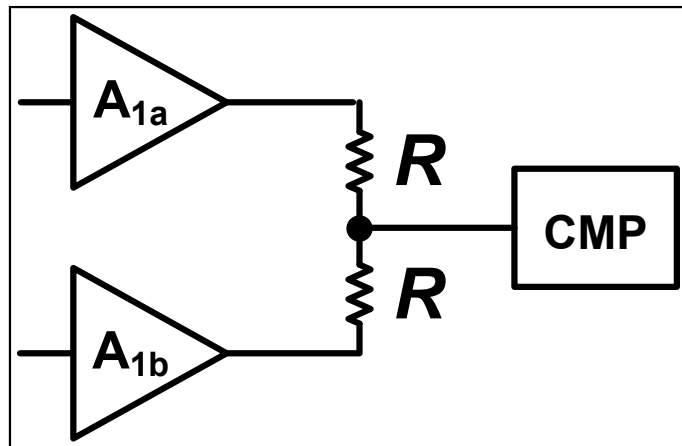
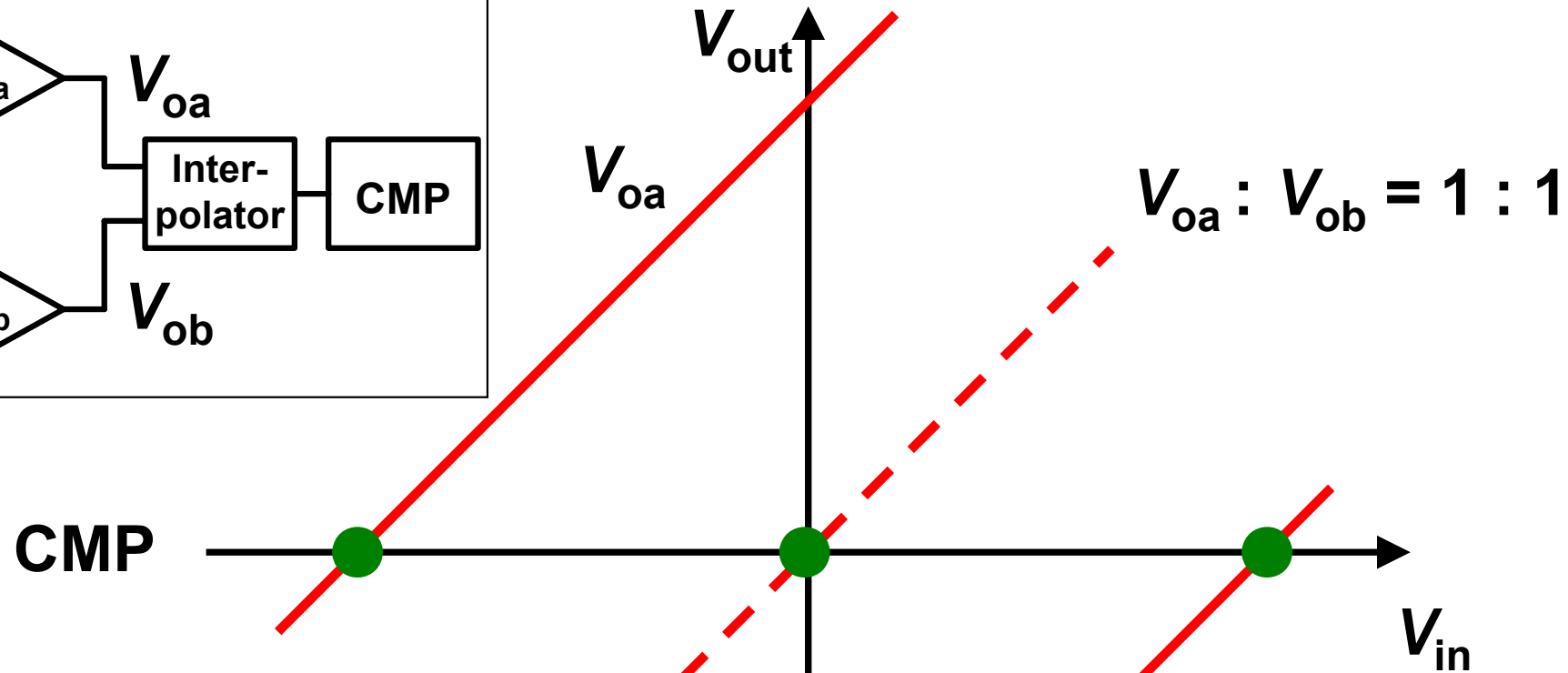
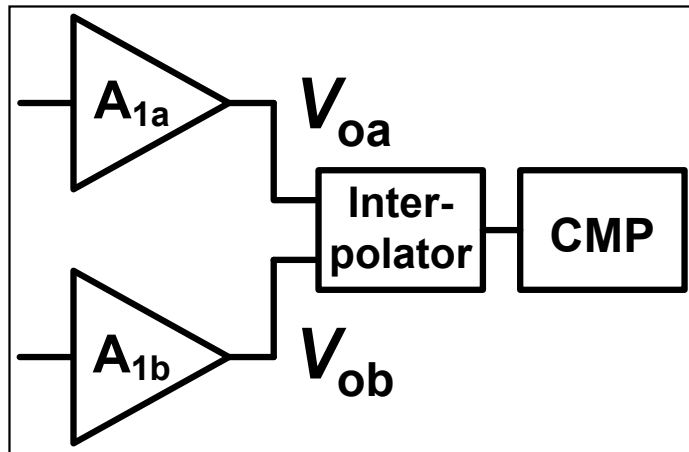
Proposed ADC

- **Target : 10bit, $F_s > 300$ MS/s**
- **Interpolation and pipelined operation**
 - **Moderate relative gain**
 - $\Delta G/G < 5\%$ for 10bit
 - Open-loop amplifiers can be used
 - No need of linearity compensation
 - **Insensitive to settling time**
 - High speed
 - Low power

Interpolation Architecture



Interpolation Architecture

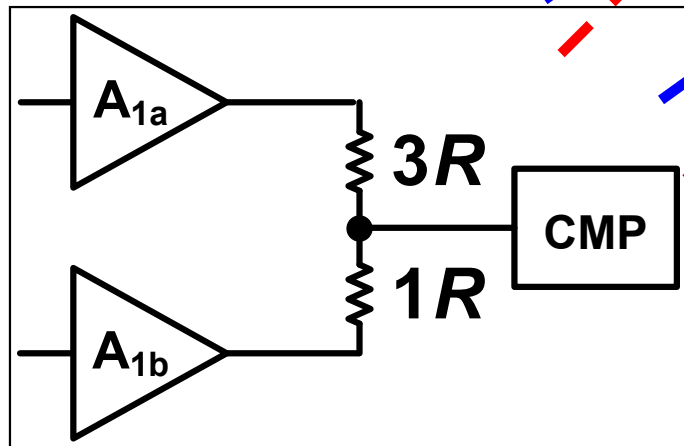
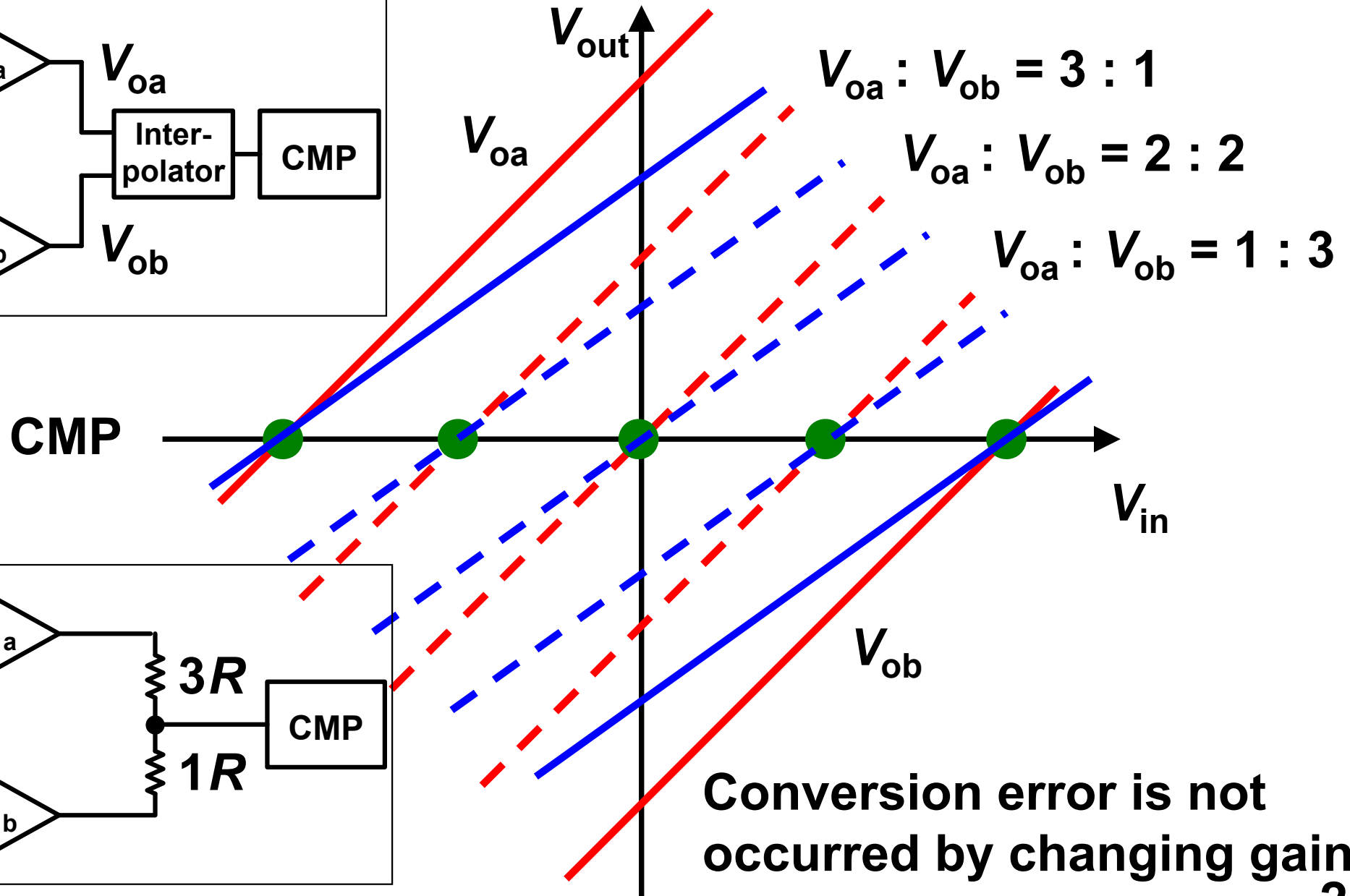
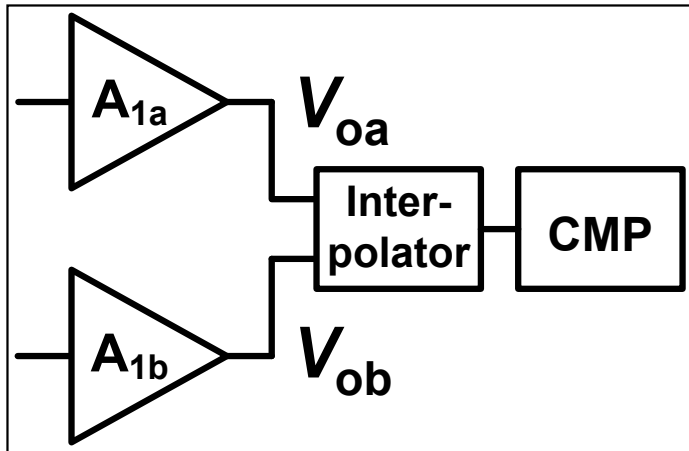


Interpolator example [3,4]

[3]A. Matsuzawa, et al. Feb. 1990.

[4]C. Mangelthdolf, et al. , Feb. 1993.

Interpolation Architecture

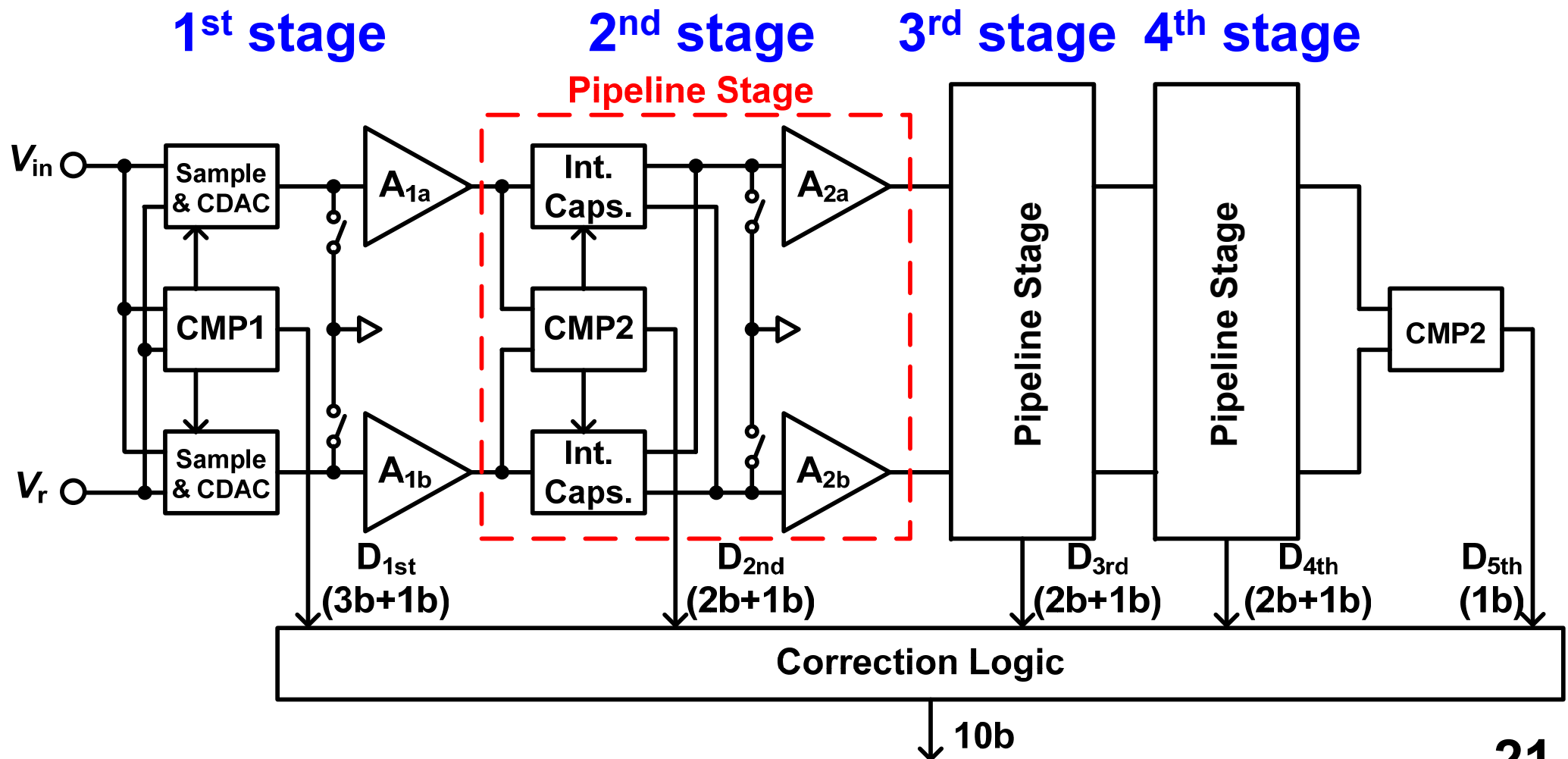


Interpolator example

Conversion error is not occurred by changing gain

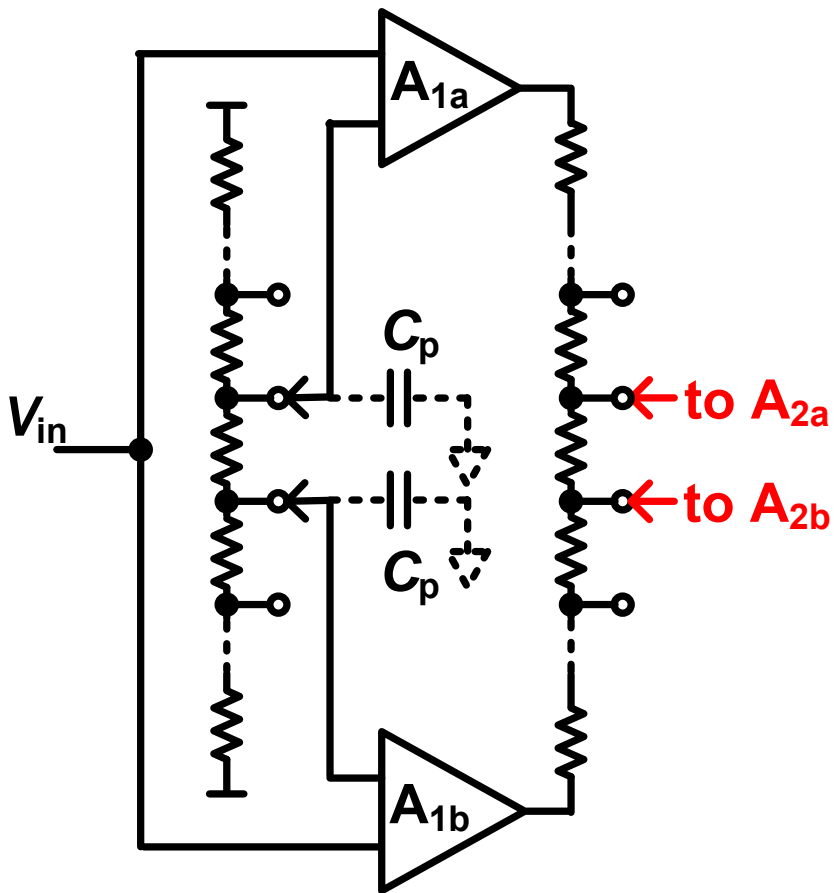
Interpolated Pipeline ADC Structure

Interpolation technique is used for 2-4th stage.
Each stage has an 1-bit redundancy.



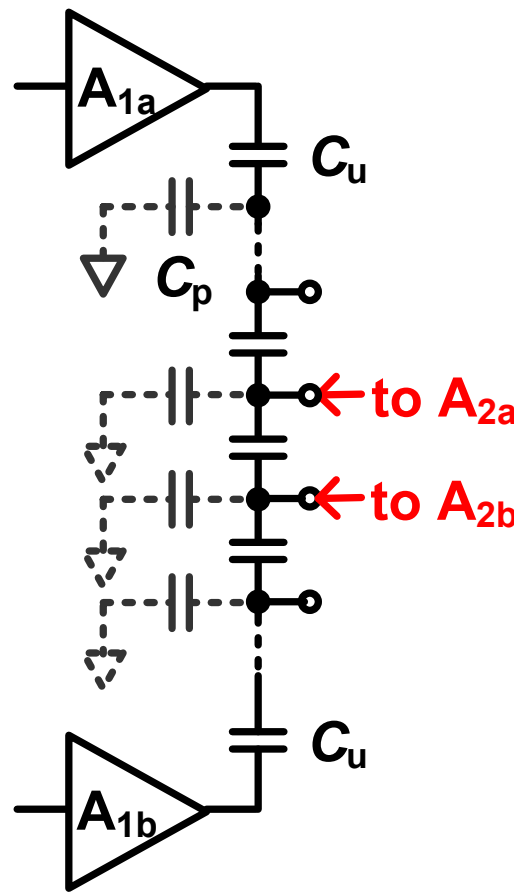
Interpolation methods

- **Static current**
- **Good linearity**
- **Imbalance settling**



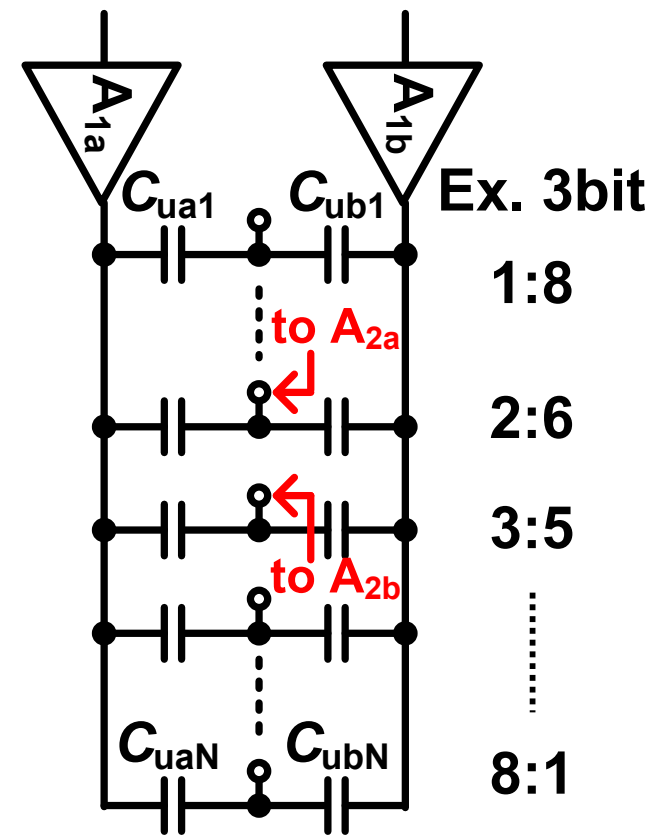
**Resistive
(Series) [3,4]**

- **No static current**
- **C_p causes nonlinearity**



**Capacitive
(Series)**

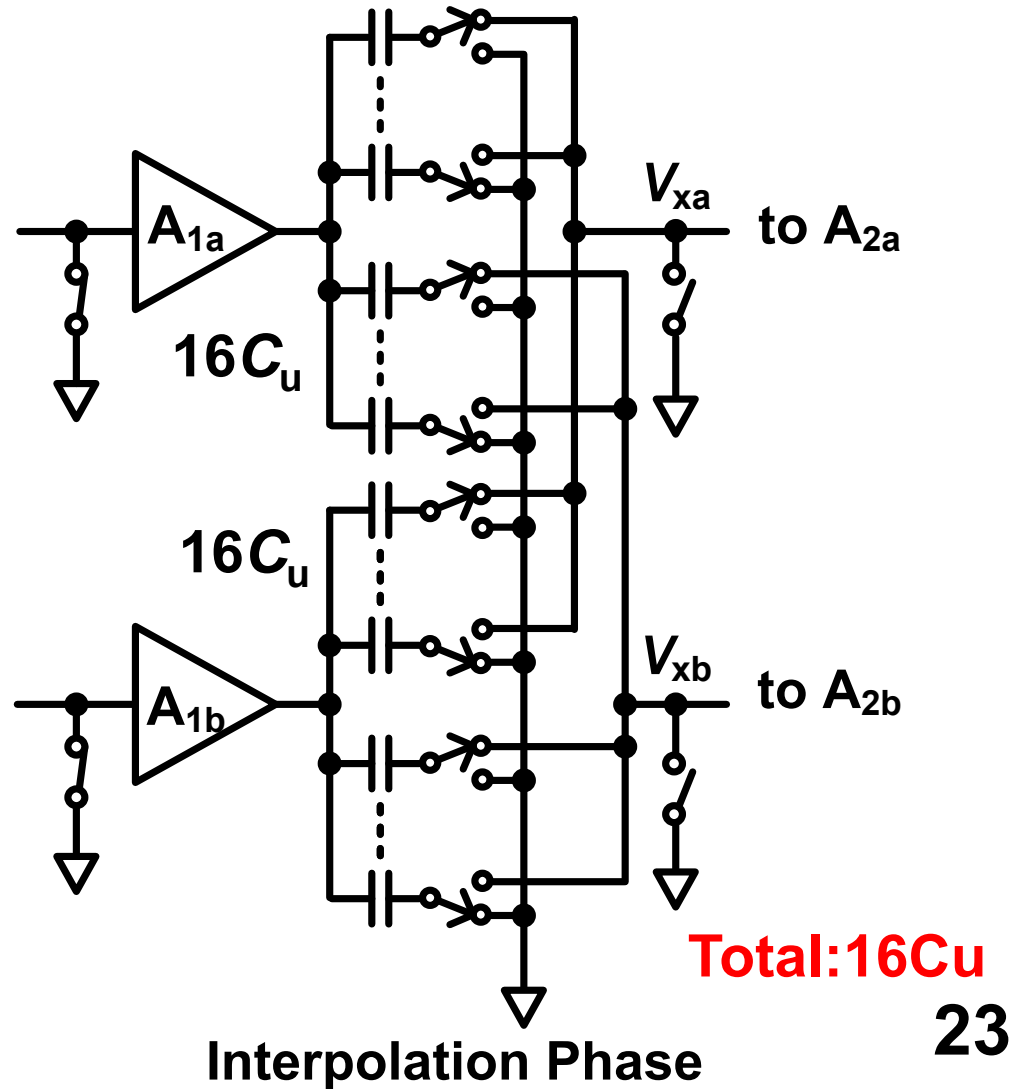
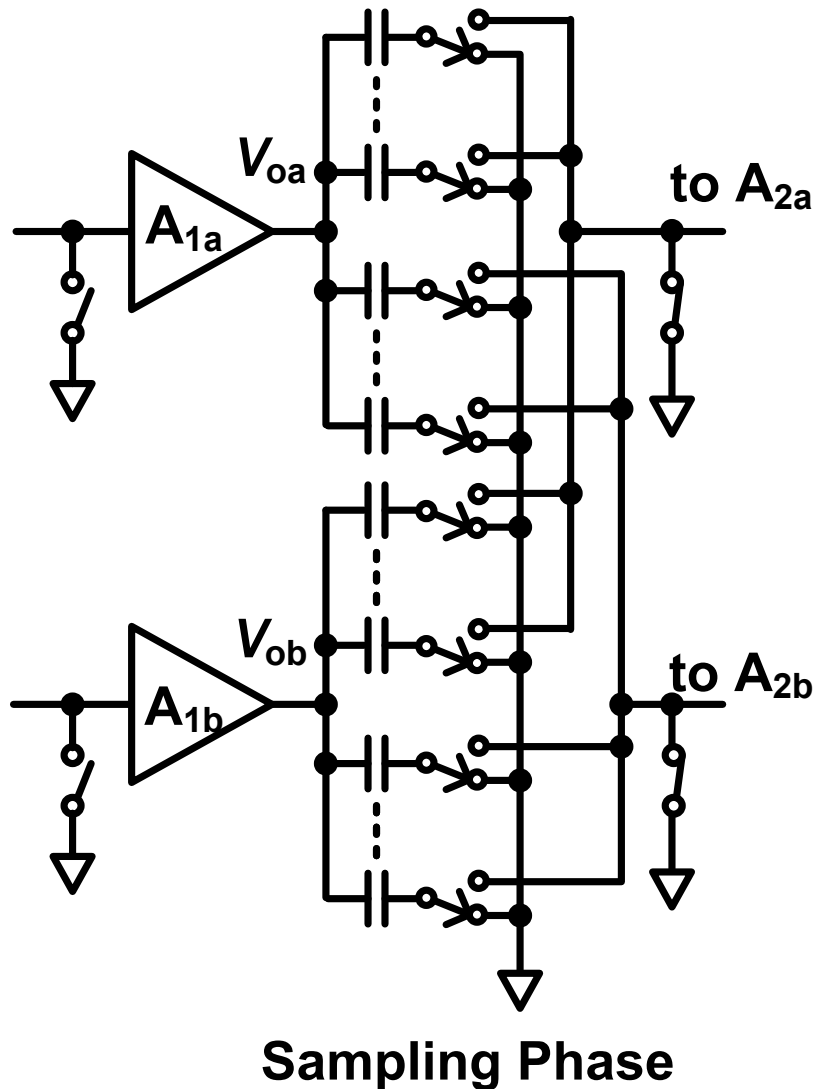
- **No static current**
- **Good linearity**
- **Heavy load**



**Capacitive
(Weighted) 22**

Proposed Weight Controlled Capacitor Array

Sub-ADC controls the capacitor weight.
Load capacitance is reduced from $36C_u$ to $16C_u$ (3bit).

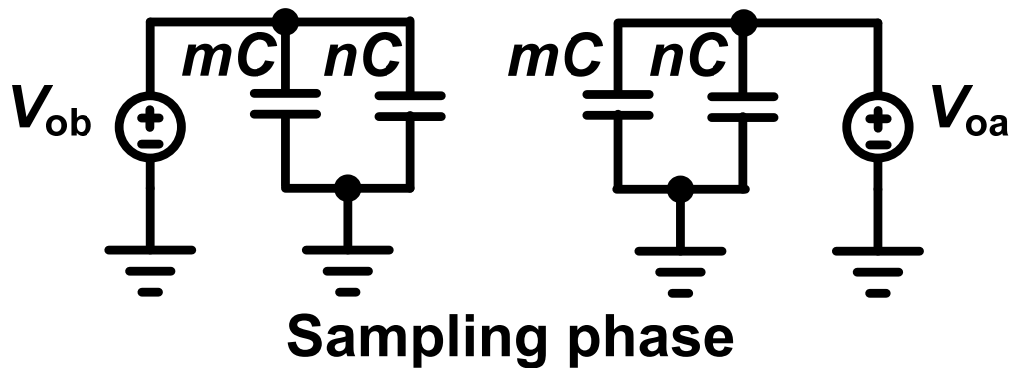


Weight Controlled Capacitor Array

Offset voltage can be cancelled in interpolation phase

$$V_x = - \left[\frac{m}{m+n} G_a (V_{in} - V_{ra}) + \frac{n}{m+n} G_b (V_{in} - V_{rb}) \right]$$

$$2^M = m+n$$

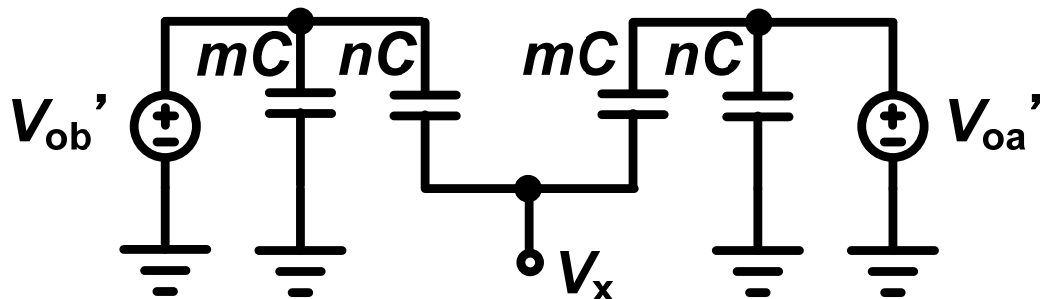


$$V_{oa} = G_a (V_{in} - V_{ra} - V_{off_a})$$

$$V_{ob} = G_b (V_{in} - V_{rb} - V_{off_b})$$

$$V'_{oa} = G_a (-V_{off_a})$$

$$V'_{ob} = G_b (-V_{off_b})$$



G_a, G_b : Gain of A_{1a} and A_{1b}

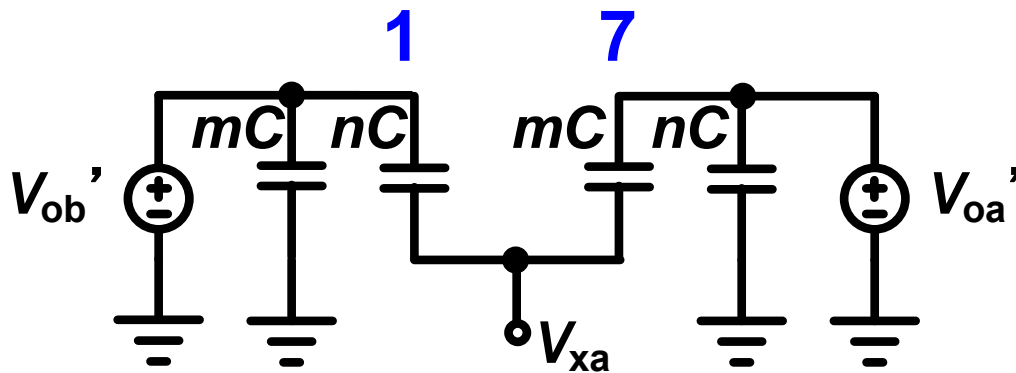
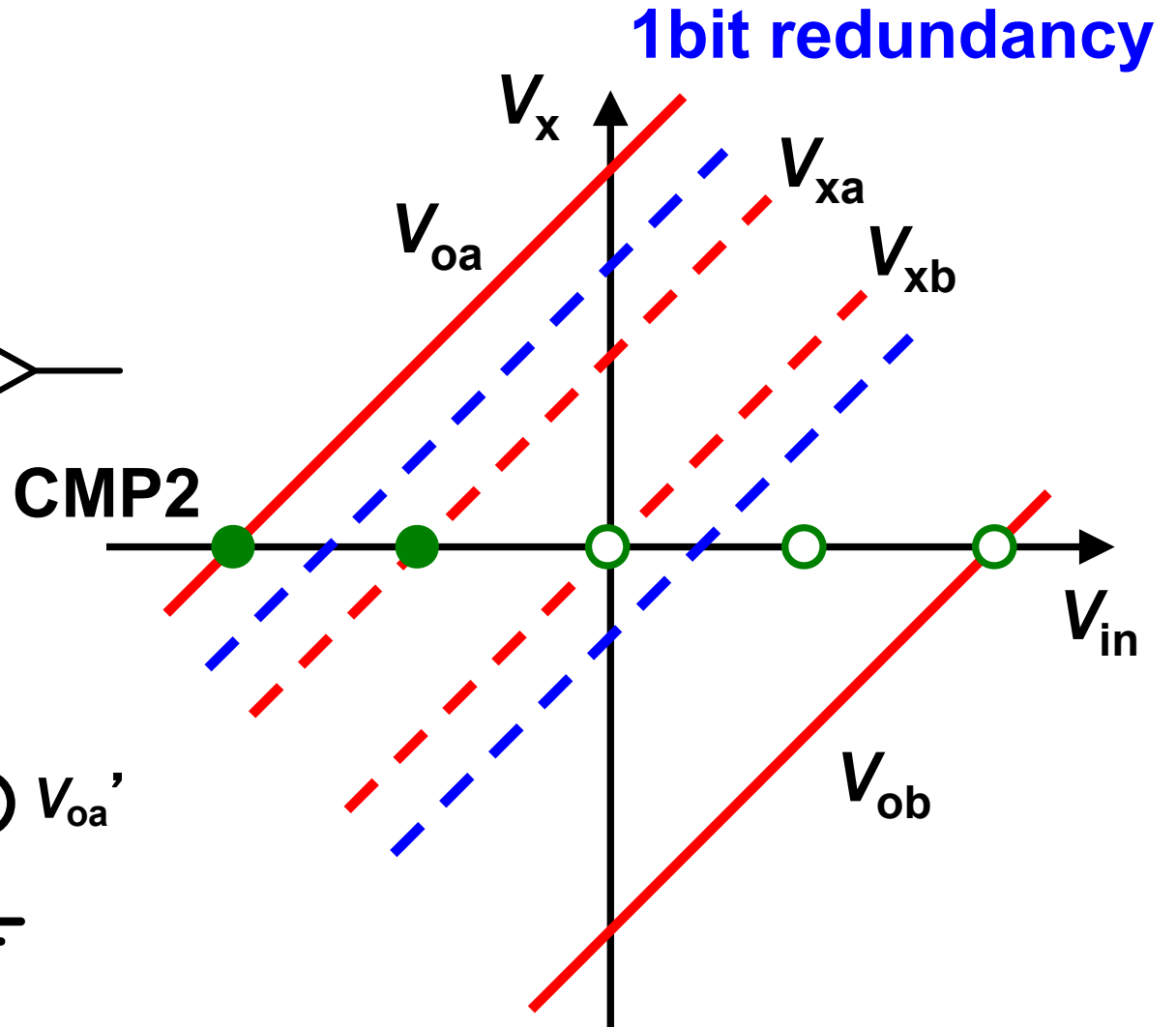
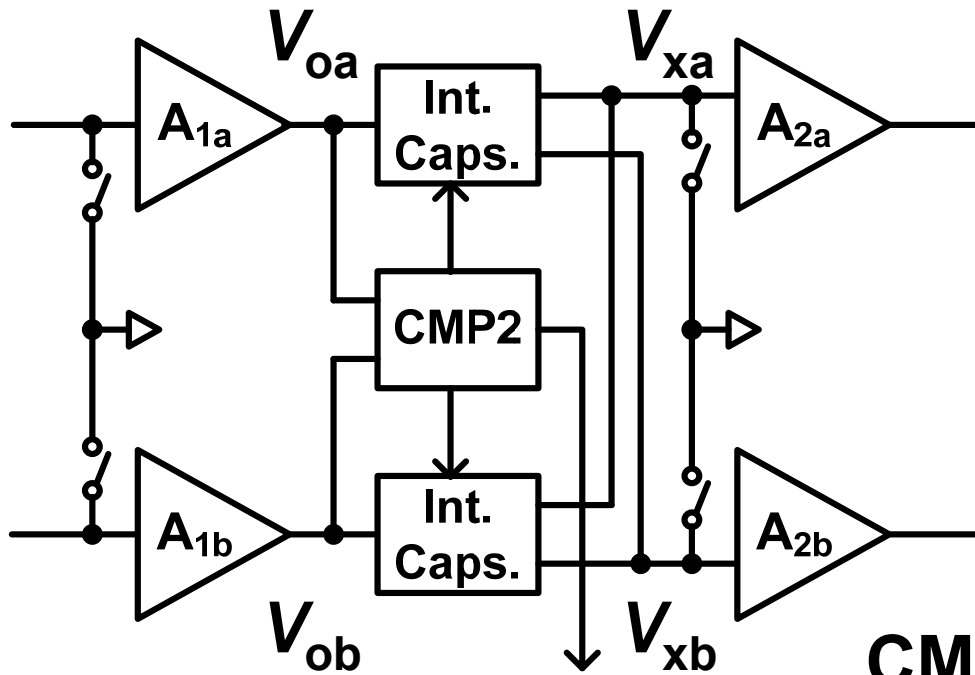
V_{oa}, V_{ob} : Output voltage

V_{off_a}, V_{off_b} : Offset voltage

V_{ra}, V_{rb} : Reference voltage

m, n : Capacitor weight

Interpolated Output

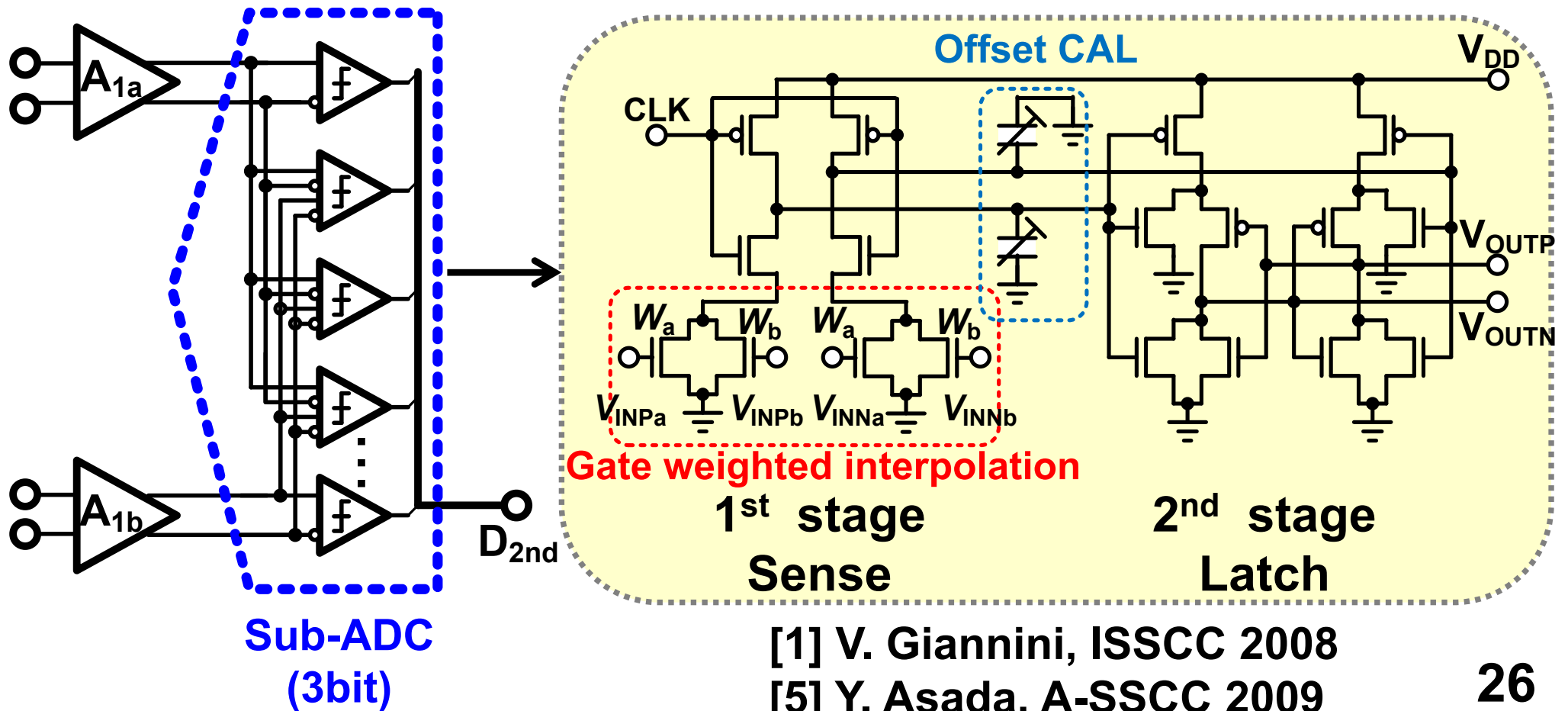


Interpolation phase

Sub-ADC Structure

Gate-width-weighted interpolation comparators with capacitive offset calibration is used.

– Offset voltage $< 2 \text{ mV } (\sigma)$



[1] V. Giannini, ISSCC 2008

[5] Y. Asada, A-SSCC 2009

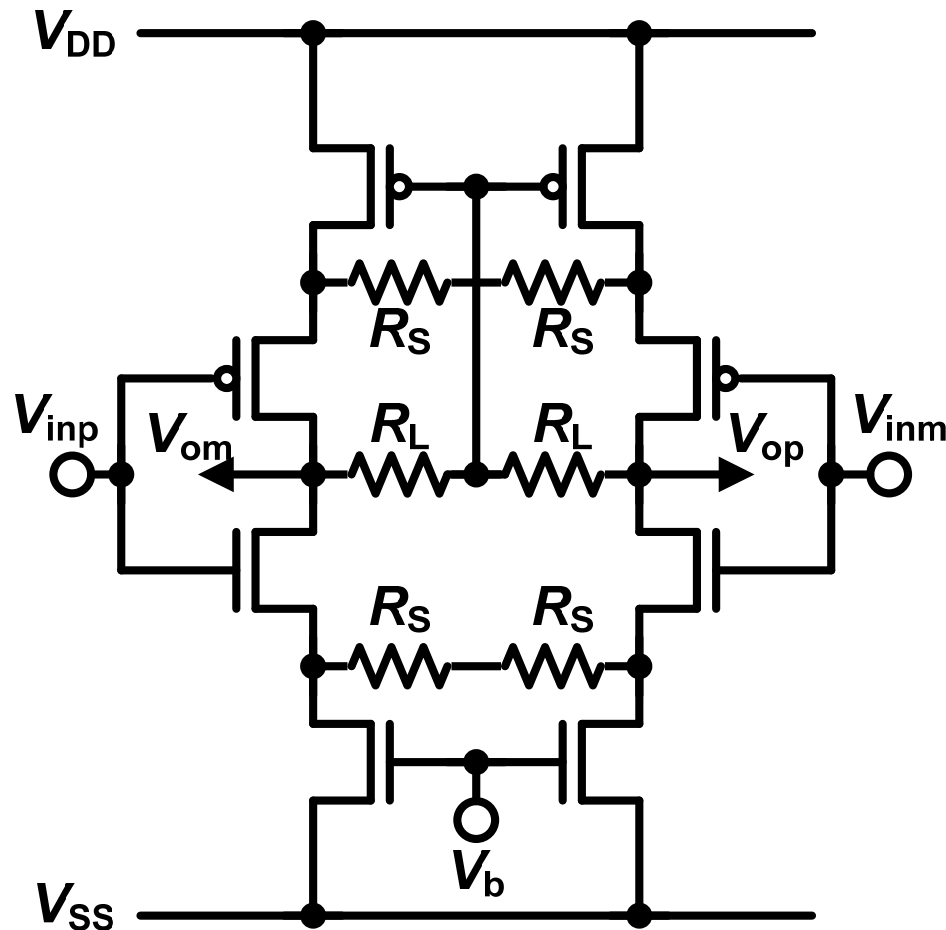
Requirements for An Amplifier

- **Absolute Gain error \Rightarrow No error**
- **Offset voltage \Rightarrow DNL error**
 - **Offset voltage $< 1\text{LSB}$**
 - **Offset voltage can be neglected by output offset cancel technique.**
- **Gain mismatch \Rightarrow DNL error**
- **Linearity \Rightarrow DNL and INL error**

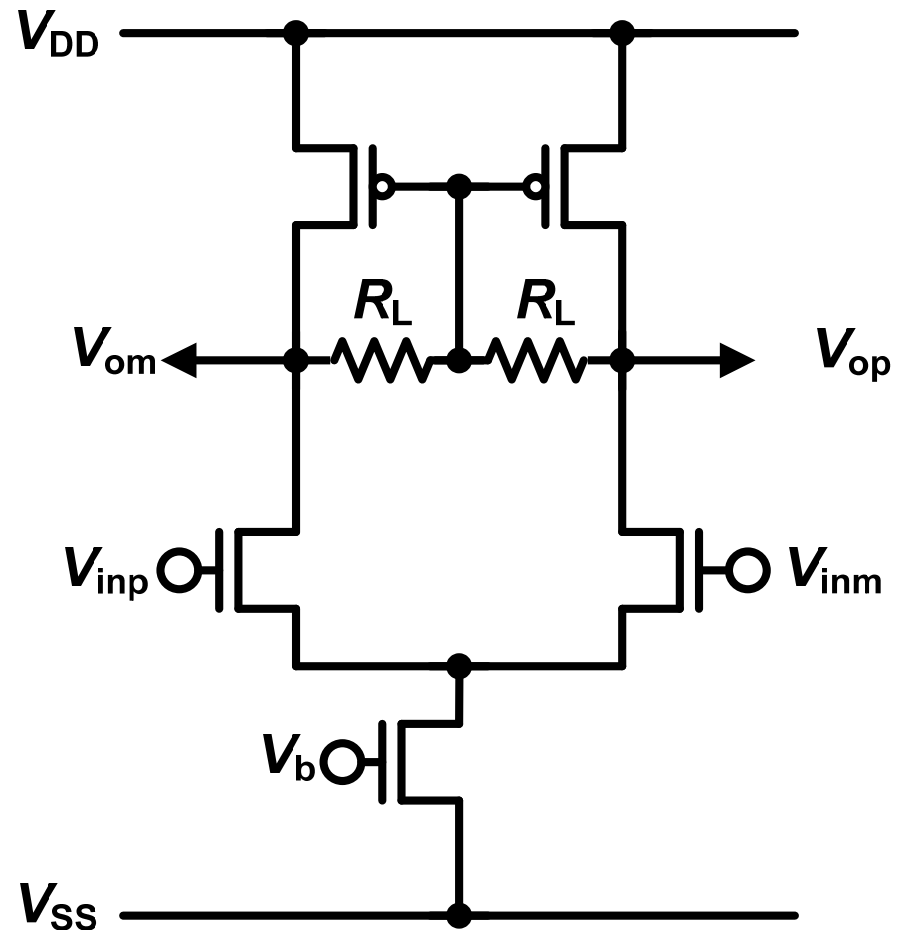
Amplifier : Schematic

1st stage amplifier require good linearity
=>CMOS input with source degenerations

Gain mismatch $< 2.1\%(3\sigma)$



1st stage amplifier



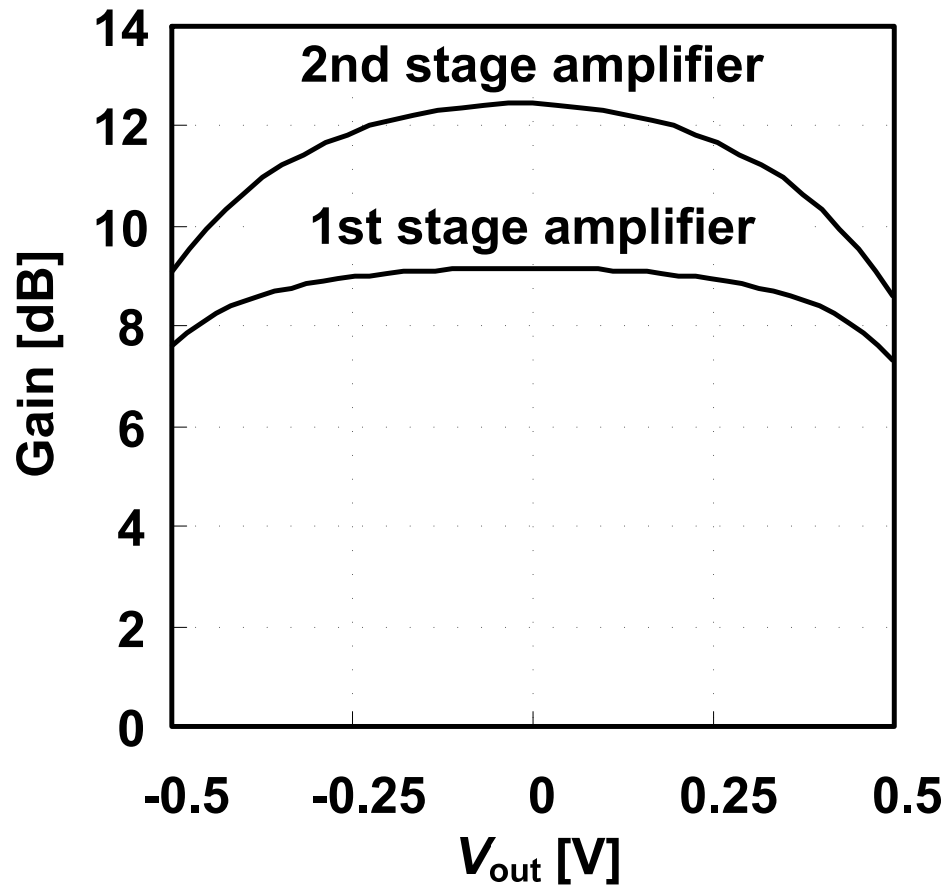
2nd stage amplifier

Amplifiers : Simulation results

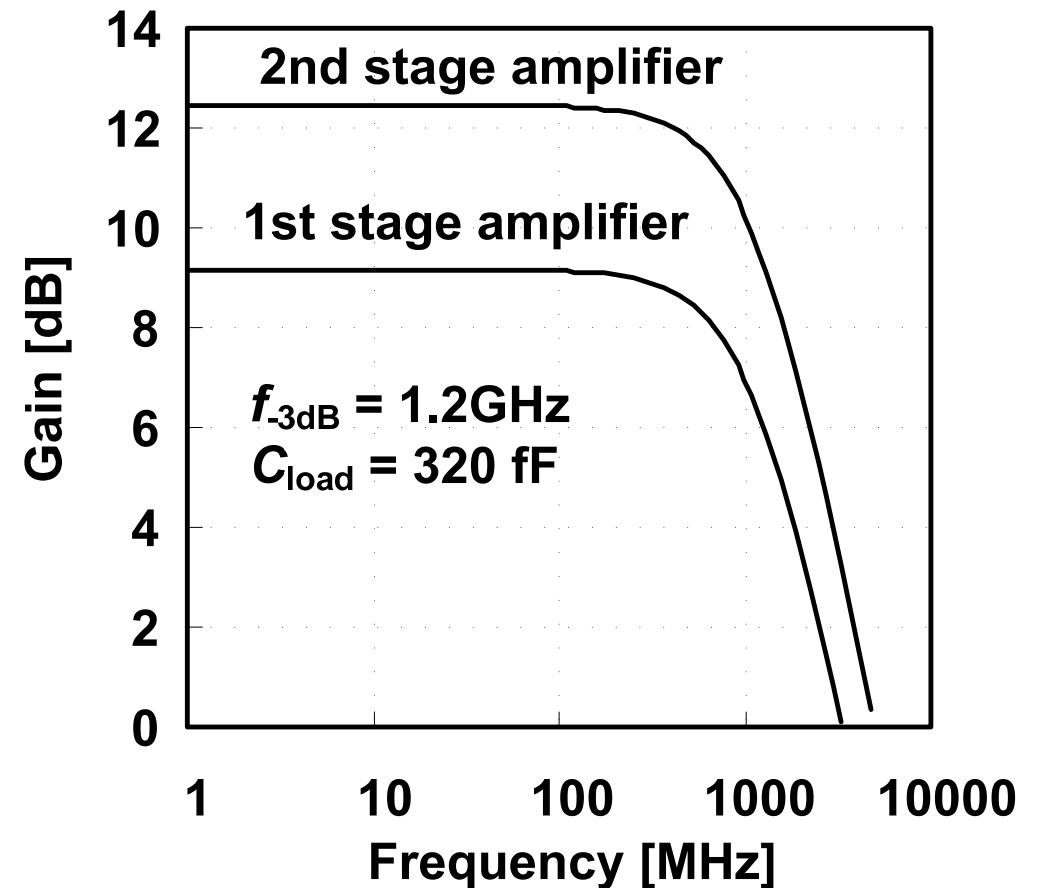
$$V_{\text{out}} \approx a_1 V_{\text{in}} - a_3 V_{\text{in}}^3$$

1st stage $a_3/a_1 < 1.3$

2nd stage $a_3/a_1 < 6.2$



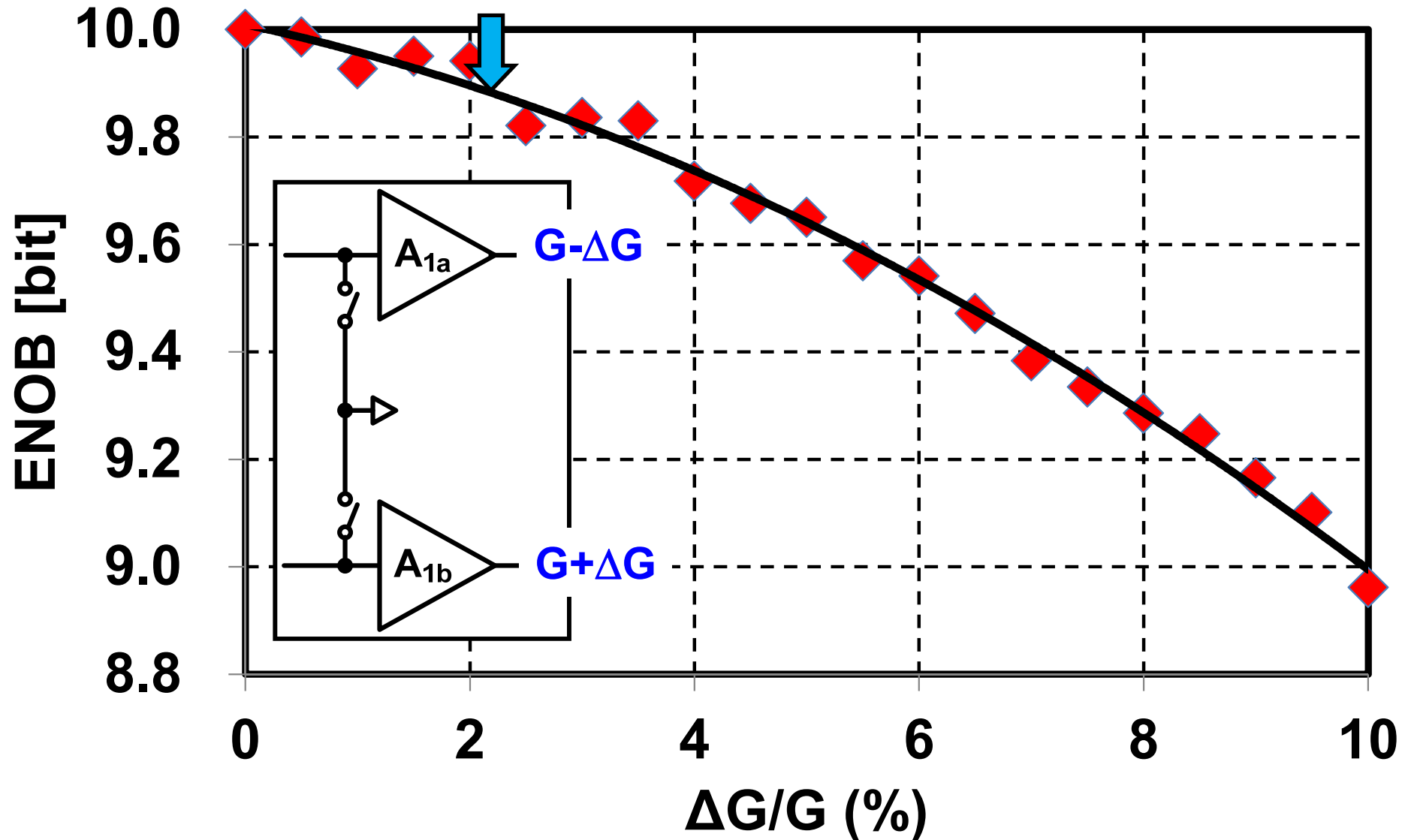
Output voltage vs. DC gain.



Frequency vs. gain.

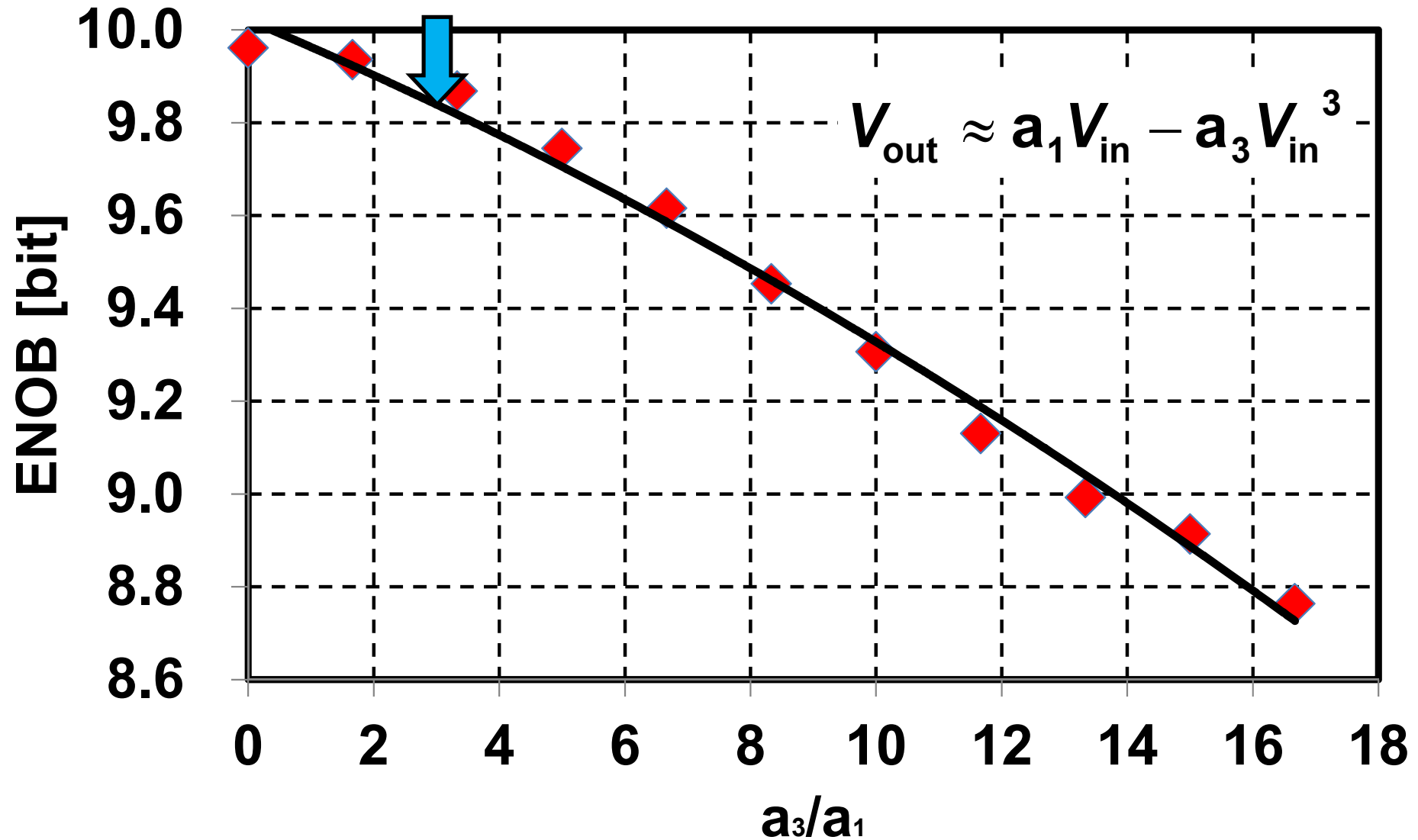
Gain matching requirement

Gain mismatch of 1st stage amplifiers $< 2.1\%(3\sigma)$



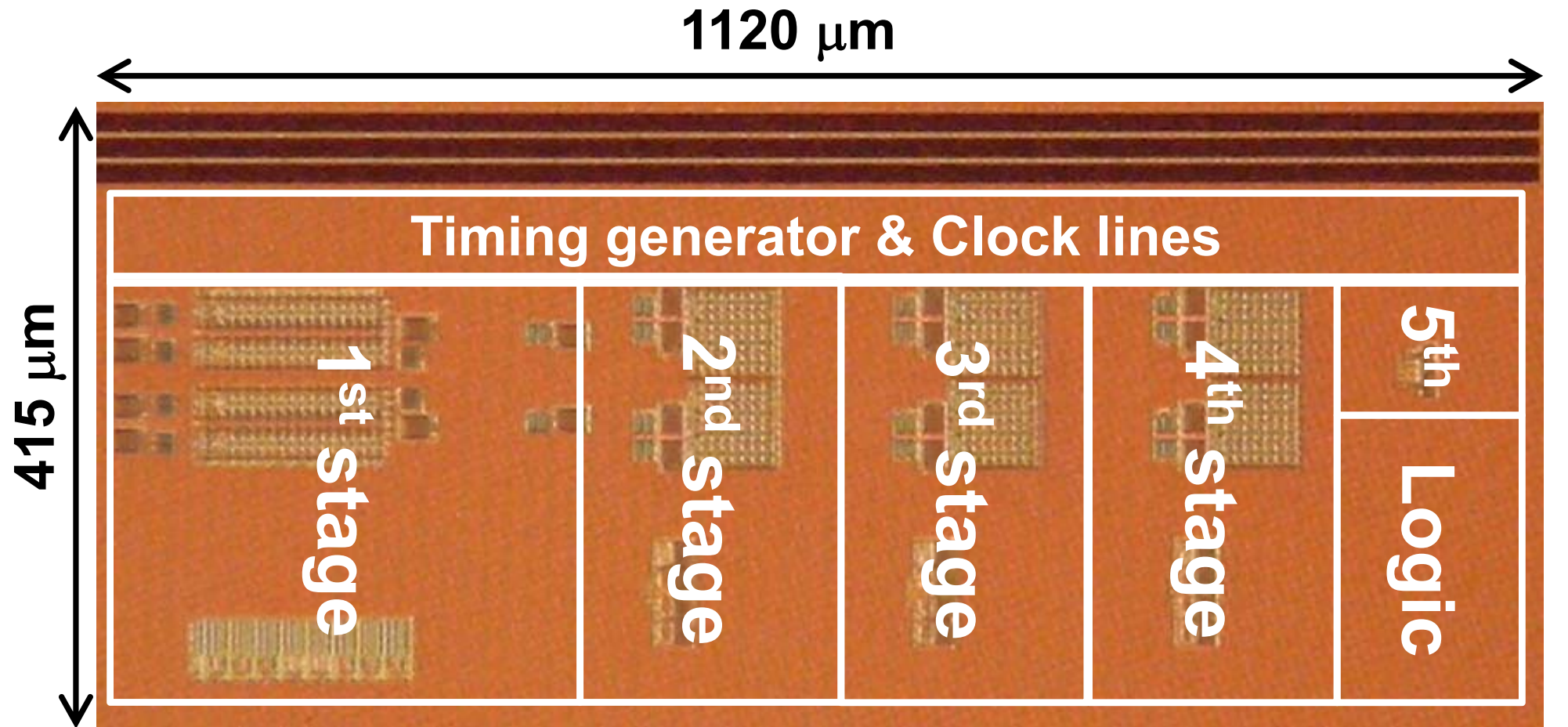
Linearity Requirement

1st stage $a_3/a_1 < 1.3$, 2nd stage $a_3/a_1 < 6.2$



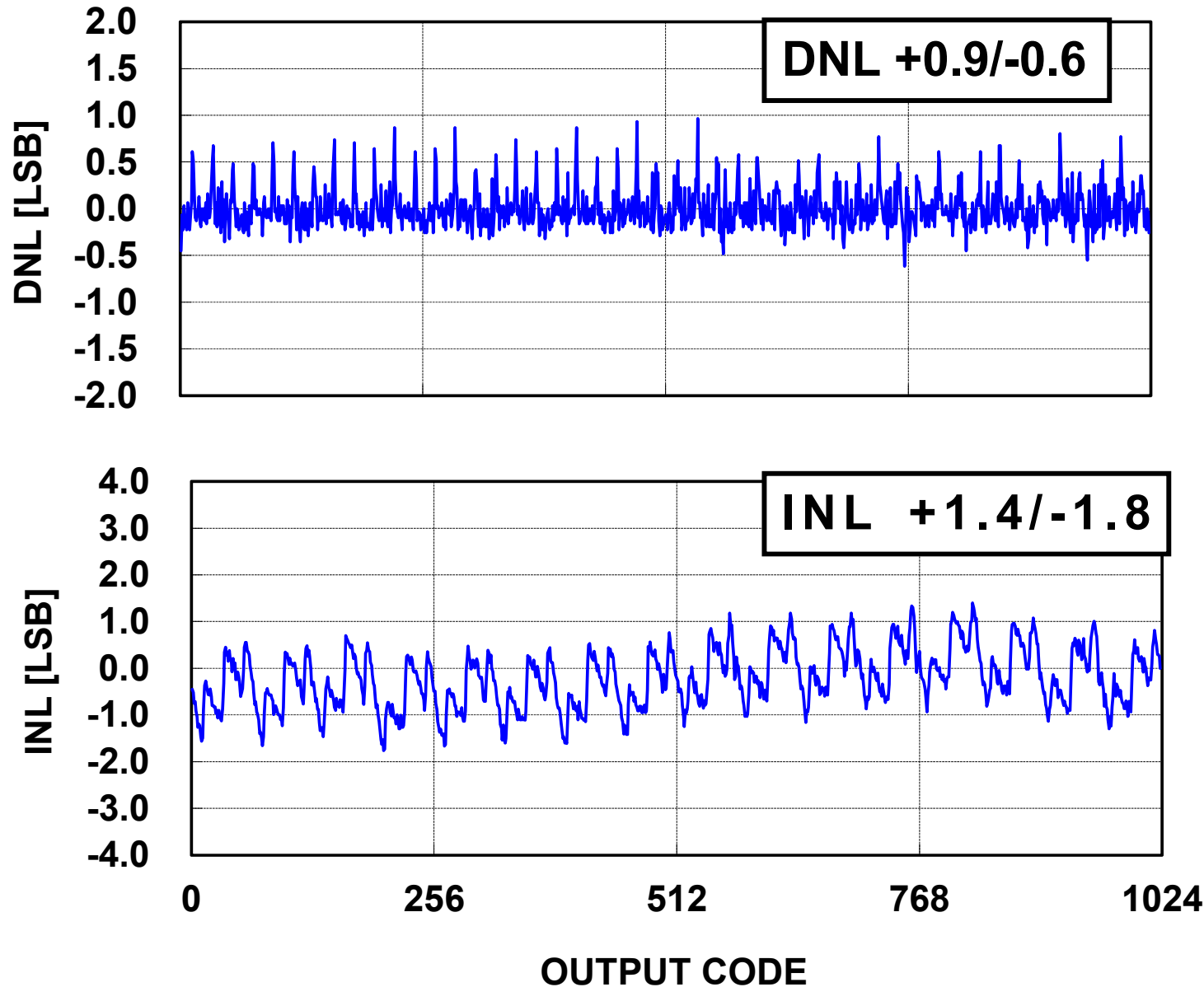
Chip photo

- 90 nm 10M1P CMOS technology
- Chip area of 0.46mm²



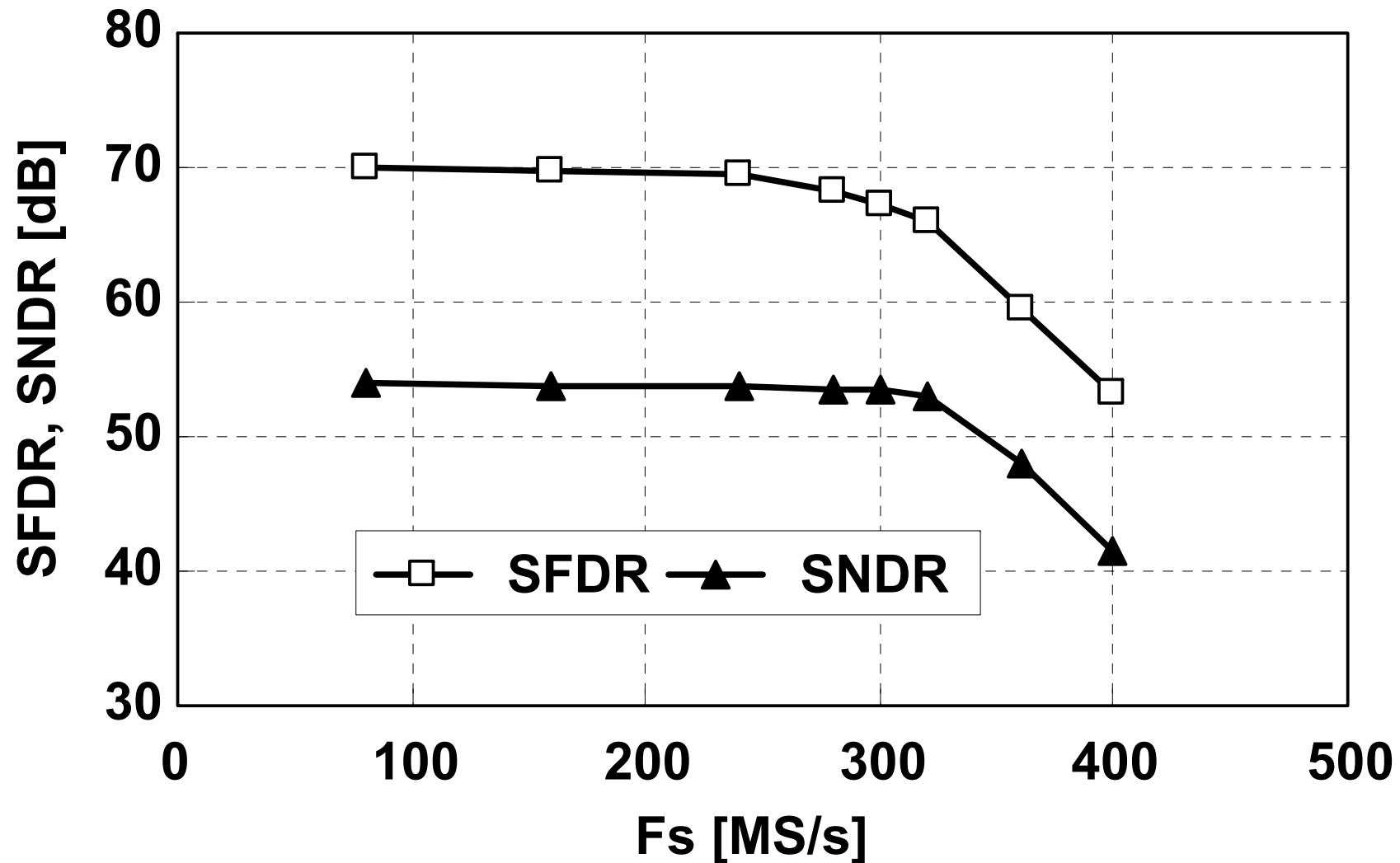
DNL, INL

This periodical error is due to bad layout, not essential issue.



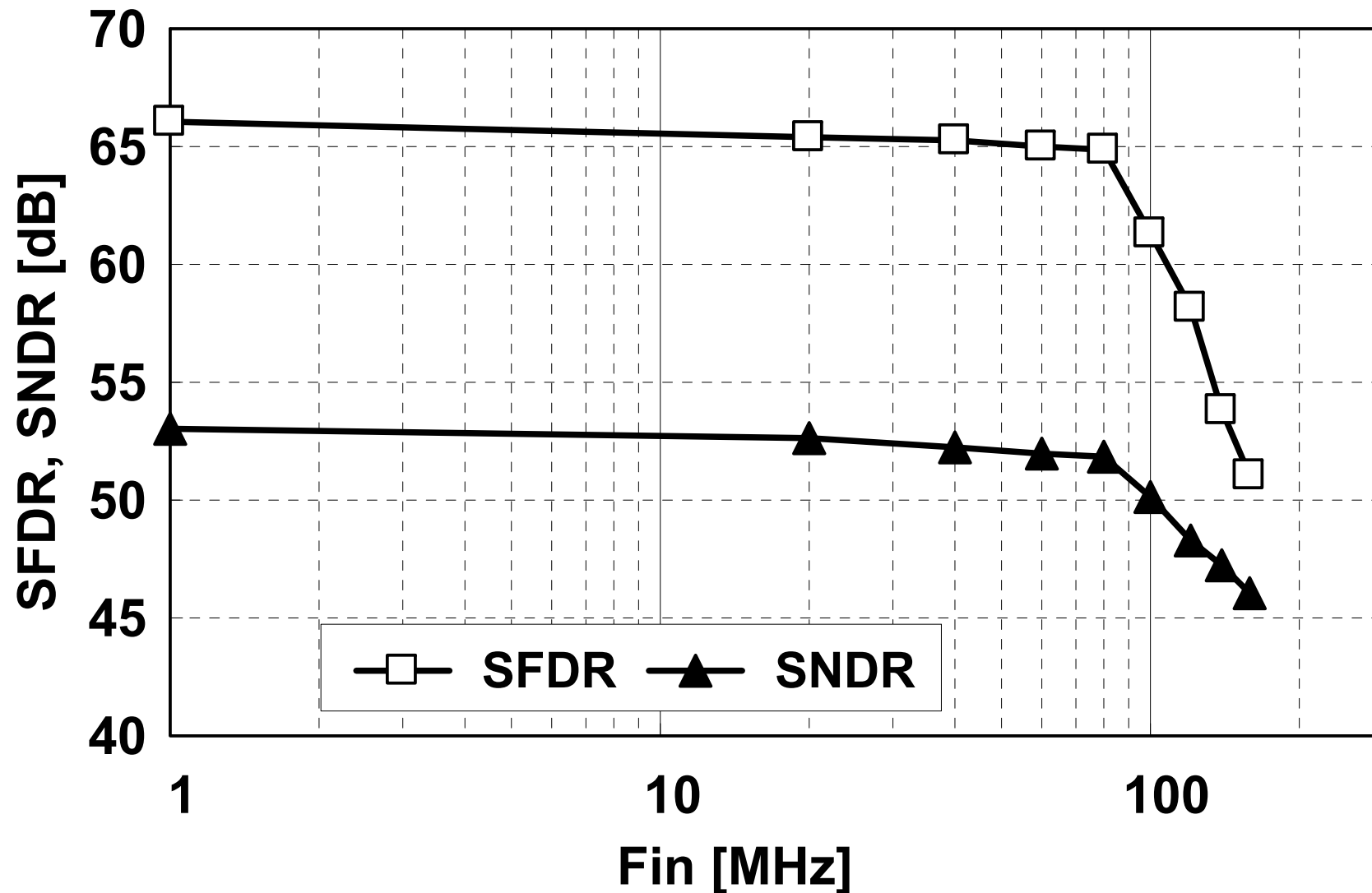
Sampling Frequency vs. SNDR

Input Frequency = 1 MHz



Input Frequency vs. SNDR

Sampling Frequency = 320 MS/s



Performance summary

	This Work	[2]	[6]	[7]
Resolution (bit)	10	10	10	10
F_{sample} (MS/s)	320	500	205	320
V_{DD} (V)	1.2	1.2	1.0	-
Power (mW)	40	55	61	42
$\text{ENOB}_{\text{peak}}$ (bit)	8.5	8.5	8.7	8.7
$\text{FoM}_{\text{FS}} / \text{FoM}_{\text{ERBW}}$ (pJ/c.-s)	0.35 / 0.77	0.31	0.65	0.36/0.44
Technology (nm)	90	90	90	90
Active Area (mm ²)	0.46	0.5	1	0.21
Amplifier type	Open	Closed	Closed	Closed
Linearity Compensation	No	Yes	No	Yes

[2] A. Verma and B. Razavi, IEEE J. Solid-State Circuits, vol. 44, Nov., 2009.

[6] S. Lee, Y. Jeon, K. Kim, J. Kwon, J. Kim, J. Moon, and W. Lee," ISSCC, 2007.

[7] H. Chen, W. Shen, W. Cheng, and H. Chen, A-SSCC, 2010.

Conclusions

- **An interpolated pipelined ADC using open-loop amplifier has been proposed.**
 - **Interpolation architecture**
 - **$\Delta G/G < 5\%$ for 10bit**
 - **Using simple open-loop amplifiers enables high speed operation**
 - **No need of a linearity compensation**
 - **Weight Controlled Capacitor Array**
 - **Load capacitance is reduced from $36C_u$ to $16C_u$**
 - **Offset voltage of the amplifier can be cancelled**
 - **10bit, 320MS/s, 40 mW ADC has been realized**

Future Prospect

- **Issue: Need twice larger circuits**
 - Same capacitance as for the conventional pipeline ADC can be used by modifying circuits.
 - Area and power can be reduced, since lower bandwidth is acceptable.
- **Still need the pipelined ADC?**
 - SAR ADC: lowest FoM, but low f_s and low resolution.
 - SAR-Pipeline: higher resolution, but lower f_s due to multi step conversions.
 - Interleaving: effective for low resolution ADC, but need totally large capacitance.